

CSW 2016 Program

June 26th (Sunday)

Short Course A

Room B (201) 14:00-15:30

Manipulation of Photons by Photonic Crystals

Susumu Noda

Kyoto University, Japan

In this short course, I will review the recent progresses in photonic crystal research, which includes (1) ultrahigh-Q nanocavities and their applications, (2) broad-area photonic-crystal cavities and their applications to high-power coherent lasers, and (3) thermal-emission control based on control of photonic and electronic states. Through such a broad-range of progresses, I hope that the audience could feel that photonic crystal research is now approaching to a goal towards “ultimate control of photons”

Short Course B

Room B (201) 16:00-17:30

New Perspectives for Oxide Semiconductors and Their Applications

~ Tuning The Electronic Properties of Oxide-Semiconductor Heterostructures ~

Akira Ohtomo

Tokyo Institute of Technology, Japan

In this lecture, a review on most intensively studied oxide semiconductors will be given with emphasis on the growth of heterostructures and the physical properties. ZnO has outstanding optical and electronic properties, such as large exciton-binding energy, excellent luminescent properties, high electron mobility, piezoelectricity, and a direct wide bandgap. All of these features and the relatively easy growth of the nanostructures have spurred the investigation of these materials for a large scope of photonics and electronics applications, including light-emitting diodes (LEDs), photodetectors, and transparent field-effect transistors. As for perovskite oxides, high-mobility two-dimensional electron gas and superconductivity can be created in SrTiO₃ based heterostructures, allowing us to explore the quantum transport in a novel class of superconducting semiconductors.

~ Current Status and Future Prospects of Gallium Oxide Technologies ~

Masataka Higashiwaki

National Institute of Information and Communications Technology, Japan

Gallium oxide (Ga₂O₃) possesses excellent material properties especially for power device applications. It is also attractive from an industrial viewpoint since large-size, high-quality wafers can be manufactured by using simple methods. These two features have drawn much

attention to Ga₂O₃ as a new wide bandgap semiconductor following SiC and GaN. This lecture will discuss the recent progress in development on fundamental technologies for Ga₂O₃ devices, covering wafer production from melt-grown bulk single crystals, homoepitaxial thin-film growth by molecular beam epitaxy and halide vapor phase epitaxy, as well as device processing and characterization of metal-oxide-semiconductor field-effect transistors and Schottky barrier diodes.

June 27th (Monday)

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| Opening Session | Room A (Main Hall) | 8:30-8:40 |
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| MoPLN1 | Plenary Session 1 | Room A (Main Hall) | 8:40-10:00 |
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Chair: H. Yamaguchi and K. Hirakawa

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| MoPLN1-1 | 8:40 - 9:20 |
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Quantum cascade laser frequency combs: physics and applications

Jerome Faist

Institute for Quantum Electronics, ETH Zurich, Switzerland

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| MoPLN1-2 | 9:20 - 10:00 |
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Novel Oxide Semiconductors for OLEDs and Catalysis

Hideo Hosono

Tokyo Institute of Technology, Japan

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| Coffee Break | 10:00 - 10:30 |
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| MoPLN2 | Plenary Session 2 | Room A (Main Hall) | 10:30-11:50 |
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Chair: Y. Miyamoto and S. Matsuo

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| MoPLN2-1 | 10:30 - 11:10 |
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Nanometer-Scale III-V CMOS

J. A. del Alamo

Microsystems Technology Laboratories, Massachusetts Institute of Technology, United States of America

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| MoPLN2-2 | 11:10 - 11:50 |
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InP-Based Integrated Optical Devices - Present and Future -

Hajime Shoji

Transmission Devices Laboratory, Sumitomo Electric Industries, LTD., Japan

ISCS/IPRM Award Ceremony Room A (Main Hall) 11:50-12:30

Lunch Break 12:30 - 14:00

MoB3 Nanocarbon & 2D Properties Room B (201) 14:00-16:00*Chair: T.Machida*

MoB3-1 (Invited) 14:00 - 14:30

What is unique in 2D-layered materials?

Young Hee Lee

CINAP, Institute for Basic Science, Sungkyunkwan University, Republic of Korea

MoB3-2 14:30 - 14:45

Effect of Defects on Graphene Thermoelectric Properties

Yuki Anno, Kuniharu Takei, Seiji Akita, and Takayuki Arie

Department of Physics and Electronics, Osaka Prefecture University, Japan

MoB3-3 14:45 - 15:00

Strain-induced Semiconducting Electron Transport in Graphene Field Effect DevicesRineka Hiraide,¹ Hiroki Sonoda,¹ Shoma Higuchi,¹ Hikari Tomori,^{1,2} and Akinobu Kanda¹*¹Division of Physics and TIMS, University of Tsukuba, Japan, ²PRESTO-JST, Japan*

MoB3-4 15:00 - 15:15

Phonon Engineering of Graphene by Local Strain

Yuki Imakita, Yuki Anno, Kuniharu Takei, Seiji Akita, and Takayuki Arie

Osaka Prefecture University, Japan

MoB3-5 15:15 - 15:30

Detection Kondo effect in Graphene Quantum DotsYasushi Kanai,¹ Takashi Ikuta,¹ Takao Ono,¹ Yasushide Ohno,^{1,2} Kenzo Maehashi,^{1,3} Koichi Inoue,¹ and Kazuhiko Matsumoto¹*¹The Institute of Scientific and Industrial Research, Osaka University, Japan, ²Tokushima University, Japan, ³Tokyo University of Agriculture and Technology, Japan*

MoB3-6 15:30 - 15:45

Effect of Metal Contact on Electron Transport and Its Removal in Graphene Field Effect DevicesShoma Higuchi,¹ Hiroki Sonoda,¹ Yu Ito,¹ Kenta Katakura,¹ Hikari Tomori,^{1,2} and Akinobu Kanda¹*¹Division of Physics and TIMS, University of Tsukuba, Japan, ²PRESTO-JST, Japan*

MoB3-7 15:45 - 16:00
Electronic structure of CNT thin films with nanointerfaces under an electronic field
 Taketo Kochi and Susumu Okada
University of Tsukuba, Japan

MoC3 Advanced Photonic Devices Room C (202) 14:00-16:00

Chair: S. Lourdudoss and M. Kondow

MoC3-1 (Invited) 14:00 - 14:30
1.5 μm Quantum Dot Lasers for Data and Telecom Applications
 Johann Peter Reithmaier¹ and Gadi Eisenstein²
¹*Institute of Nanostructure Technologies & Analytics, Cinsat, University of Kassel, Germany,* ²*Optical Communication Laboratory, Department of Electrical Engineering, Technion, Israel*

MoC3-2 (Invited) 14:30 - 15:00
Epitaxial growth on lattice-mismatched substrate for high-performance lasers
 Ryo Nakao,^{1,2} Masakazu Arai,^{1,2} Wataru Kobayashi,² Takaaki Kakitsuka,^{1,2} Tsuyoshi Yamamoto,² and Shinji Matsuo^{1,2}
¹*NTT Nanophotonics center, NTT Corp., Japan,* ²*NTT Device Technology Labs., NTT Corp., Japan*

MoC3-3 15:00 - 15:15
Direct Modulation of InAs/GaAs Quantum Dot Lasers on Silicon at 60 °C
 Yuan-Hsuan Jhang,¹ Reio Mochida,² Katsuaki Tanabe,^{2,3} Keizo Takemasa,⁴ Mitsuru Sugawara,⁴ Satoshi Iwamoto,^{1,2} and Yasuhiko Arakawa^{1,2}
¹*Institute of Industrial Science, The University of Tokyo, Japan,* ²*Institute of Nano Quantum Information Electronics, The University of Tokyo, Japan,* ³*Department of Chemical Engineering, Kyoto University, Japan,* ⁴*QD Laser, Inc., Japan*

MoC3-4 15:15 - 15:30
Large Modulation Bandwidth (13.1 GHz) of 1.3 μm -Range Quantum Dot Lasers with High Dot Density and Thin Barrier Layer
 Takeo Kageyama,¹ Quoc Huy Vo,² Katsuyuki Watanabe,² Keizo Takemasa,³ Mitsuru Sugawara,³ Satoshi Iwamoto,^{1,2} and Yasuhiko Arakawa^{1,2}
¹*Institute for Nano Quantum Information Electronics, University of Tokyo, Japan,* ²*Institute of Industrial Science, University of Tokyo, Japan,* ³*QD Laser, Inc., Japan*

MoC3-5 15:30 - 15:45
Optical Pulse Response of 20 Layer-stacked QD-SOA Grown with the Strain Compensation Technique by Using an Optical Frequency Comb
 Atsushi Matsumoto, Kouichi Akahane, Takahide Sakamoto, Toshimasa Umezawa, Atsushi Kanno, and Naokatsu Yamamoto
National Institute of Information and Communications Technology, Japan

MoC3-6 15:45 - 16:00
Highly Fabrication Tolerant Polarization Converter for Generic Photonic Integration Technology

Moritz Baier, Francisco Manuel Soares, Tom Gaertner, Robert Weiser, Martin Moehrle, Norbert Grote, and Martin Schell

Fraunhofer HHI, Germany

MoD3 Epitaxy & Nano I

Room D (203) 14:00-16:00

Chair: M. Sugiyama and M. Pristovsek

MoD3-1 (Invited) 14:00 - 14:30
Non-invasive structural analysis of InP quantum dots and other nanostructures using nuclear magnetic resonance

Evgeny A. Chekhovich

Department of Physics And Astronomy, University of Sheffield, United Kingdom

MoD3-2 (Invited) 14:30 - 15:00
Crossed InSb nanowire junctions for Majorana operations

Erik Bakkers,^{1,2} Marcel Verheijen,³ Leo Kouwenhoven,² Diana Car,¹ Sasa Gazibegovic,² Elham Fadaly,² and Hao Zhang²

¹TU Eindhoven, Netherlands, ²TU Delft, Netherlands, ³Philips Research, Netherlands

MoD3-3 15:00 - 15:15
Site-defined InP/InAs heterostructure nanowires with tunable diameter by in-situ diameter-tuning technique

Guoqiang Zhang,^{1,2} Kouta Tateno,^{1,2} Tetsuomi Sogawa,¹ and Hideki Gotoh¹

¹NTT Basic Research Laboratories, NTT Corporation, Japan, ²NTT Nanophotonics Center, NTT Corporation, Japan

MoD3-4 15:15 - 15:30
Bright LEDs Using Position-controlled MOCVD Growth of InP Nanopillar Array on a Silicon Substrate

Saniya Deshpande, Indrasen Bhattacharya, Gilliard Nardel Malheiros Silveira, Willi Mantei, Kevin Cook, and Constance Chang-Hasnain

University of California-Berkeley, United States of America

MoD3-5 15:30 - 15:45
Synchrotron X-ray Diffraction in Air and Vacuum: Strain and Structure at the Nano-scale

Christopher Burrows,¹ Thomas Hase,¹ James Aldous,¹ Stuart Hatfield,¹ Mark Ashwin,² and Gavin Bell¹

¹Department of Physics, University of Warwick, United Kingdom, ²Department of Chemistry, University of Warwick, United Kingdom

MoD3-6 15:45 - 16:00

Quantum Confinement Phenomena in Ultrathin GaAs Nanowires

Bernhard Loitsch,¹ Julia Winnerl,¹ Daniel Rudolph,¹ Marcus Müller,² Peter Veit,² Frank Bertram,² Jürgen Christen,² Gerhard Abstreiter,¹ Jonathan J. Finley,¹ and Gregor Koblmüller¹

¹Walter Schottky Institut, Technical University of Munich, Germany, ²Institute of Experimental Physics, Otto-von-Guericke-University Magdeburg, Germany

Coffee Break

16:00 - 16:30

MoB4 Physics of Nanostructures

Room B (201) 16:30-18:30

Chair: S. Moriyama

MoB4-1 (Invited) 16:30 - 17:00

From charge detection to Coulomb drag in hybrid graphene/GaAs devices

Pauline Simonet, Clemens Rössler, Tobias Krähenmann, Szymon Hennel, Anastasia Varlet, Hiske Overweg, Marius Eich, Christian Reichl, Werner Wegscheider, Thomas Ihn, and Klaus Ensslin

Solid State Physics Laboratory, ETH Zürich, Switzerland

MoB4-2 17:00 - 17:15

Anomalous Conductance Fluctuations in Bilayer Graphene in h-BN Layers

Masaaki Mineharu,¹ Masahiro Matsunaga,¹ Yuichi Ochiai,¹ Inyeal Lee,^{1,2} Gil-Ho Kim,² Kenji Watanabe,³ Takashi Taniguchi,³ David K. Ferry,⁴ Jonathan P. Bird,⁵ and Nobuyuki Aoki¹

¹Chiba University, Japan, ²Sungkyunkwan University, Republic of Korea, ³National Institute for Materials Science, Japan, ⁴Arizona State University, United States of America, ⁵University at Buffalo, Suny, United States of America

MoB4-3 17:15 - 17:30

Controlled one-dimensional channel in a quantum point contact with a triple-gate structure

Motoi Takahashi, Mohammad Hamzah Fauzi, Shunta Maeda, Katsumi Nagase, Ken Sato, and Yoshiro Hirayama

Department of Physics, Tohoku University, Japan

MoB4-4 17:30 - 17:45

Measurement of Polarization Dependence of Two-Photon Absorption Coefficient β in InP Using Extended Z-scan Technique for Thick Materials

Masaki Oishi, Hiroyuki Bando, Tomohisa Shinozaki, Hikaru Hara, and Toshio Matsusue

Department of Nanomaterial Science, Chiba University, Japan

MoB4-5 17:45 - 18:00

Microwave Resonance through the Superconducting Circuit Cavity Coupled with InSb Double Quantum Dots

Rui Wang,¹ Russell S. Deacon,^{1,2} Diana Car,³ Erik P. A. M. Bakkers,³ and Koji Ishibashi^{1,2}

¹Advanced Device Laboratory, Riken, Japan, ²Center for Emergent Matter Science, Riken, Japan, ³Department of Applied Physics, Eindhoven University of Technology, Netherlands

MoB4-6 18:00 - 18:15
Room temperature, very sensitive bolometer using doubly clamped microelectromechanical oscillators

Ya Zhang,¹ Yasuyuki Watanabe,¹ Suguru Hosono,¹ Naomi Nagai,¹ and Kazuhiko Hirakawa^{1,2}

¹Center for Photonics Electronics Convergence, Institute of Industrial Science, University of Tokyo, Japan, ²Institute for Nano Quantum Information Electronics, University of Tokyo, Japan

MoB4-7 18:15 - 18:30
Multi-Mode Optical Feedback Control of GaAs Mechanical Resonators

Ryuichi Ohta, Hajime Okamoto, Daiki Hatanaka, and Hiroshi Yamaguchi

NTT Basic Research Laboratories, NTT Corporation, Japan

MoC4 Devices for Optical Communication

Room C (202) 16:30-18:30

Chair: N. Yokouchi

MoC4-1 (Invited) 16:30 - 17:00

Narrow Linewidth Tunable Semiconductor Laser

Yasuhiro Matsui,¹ Urban Eriksson,² Jan-Olof Westrom,² Yitong Liu,² Stefan Hammerfeldt,² Martin Hassler,² Björn Stoltz,² Niclas Carlsson,² Salehe Siraj,² and Edgard Goobar²

¹Finisar Corp., United States of America, ²Finisar Sweden Ab, Sweden

MoC4-2 17:00 - 17:15

Widely Tunable 1060-nm High-Contrast Grating VCSEL

Kun Li,² Chris Chase,¹ Yi Rao,¹ and Connie J. Chang-Hasnain²

¹Bandwidth 10 Inc., United States of America, ²University of California at Berkeley, United States of America

MoC4-3 17:15 - 17:30

Monolithically Integrated Low-Cost 10Gb/s Tuneable Transmitter using a Slotted Fabry-Pérot Laser

Prasanna Ramaswamy,¹ James O'Callaghan,¹ Frank H. Peters,^{1,2} Brian Corbett,^{1,2} and Brendan Roycroft¹

¹Tyndall National Institute, University College Cork, Ireland, ²Department of Physics, University College Cork, Ireland

MoC4-4 17:30 - 17:45

155nm-Span Multi-Wavelength DFB Laser Array Fabricated by Selective Area Growth

Francisco Soares,¹ Moritz Baier,¹ Ziyang Zhang,¹ Tom Gaertner,¹ Dieter Franke,¹ Jean Decobert,² Mohand Achouche,² Detlef Schmidt,¹ Martin Moehrle,¹ Norbert Grote,¹ and Martin Schell¹

¹Fraunhofer Heinrich Hertz Institute, Germany, ²III-V Lab, France

MoC4-5 17:45 - 18:00
Small Responsivity Imbalance of InP-based p-i-n Photodiode Array Monolithically Integrated with 90° Hybrid Using Asymmetric Waveguide Phase Shifter for Coherent Detection

Takuya Okimoto,¹ Higeiki Yagi,^{1,2} Ryuji Masuyama,^{1,2} Kenji Sakurai,¹ Yoshifumi Nishimoto,¹ Takehiko Kikuchi,² Kazuhiko Horino,^{1,2} Takayuki Watanabe,¹ Mitsuru Ekawa,² Masaru Takechi,² and Yoshihiro Yoneda¹

¹Sumitomo Electric Device Innovations, Inc., Japan, ²Transmission Devices Laboratory, Sumitomo Electric Industries, Ltd., Japan

MoC4-6 18:00 - 18:15
Noise investigation of Single Section InAs/ InP Quantum-dash Lasers in Active and Passive Mode-locking

Vivek Panapakkam,¹ Aravind Anthur,² Vidak Vujicic,² Rui Zhou,² Quentin Gaimard,¹ Kamel Merghem,¹ Guy Aubin,¹ Francois Lelarge,³ Liam Barry,² and Abderrahim Ramdane¹

¹CNRS, Laboratory for Photonics and Nanostructures, France, ²School of Electronic Engineering, Dublin City University, Ireland, ³III-V Lab, France

MoC4-7 18:15 - 18:30
1.55- μ m ultrashort pulse InAs/InP quantum dot mode-locked lasers with high output power

Feng Gao, Shuai Luo, Hai-Ming Ji, Feng Xu, Zun-Ren Lv, and Tao Yang

Institute of Semiconductors, Chinese Academy of Sciences, China

MoD4 Epitaxy & Nano II

Room D (203) 16:30-18:30

Chair: S. Tsukamoto and M. Yoshimoto

MoD4-1 (Invited) 16:30 - 17:00
Interface formation in semiconductor heterostructures at atomic resolution

Kerstin Volz

Philipps-University Marburg, Germany

MoD4-2 (Invited) 17:00 - 17:30
Integration of III-V heterostructure tunnel FETs on Si using template assisted selective epitaxy (TASE)

Kirsten Emilie Moselund,¹ Davide Cutaia,¹ Heinz Schmid,¹ Mattias Borg,¹ Saurabh Sant,² Andreas Schenk,² and Heike Riel¹

¹IBM Research Zurich, Switzerland, ²ETH Zürich, Integrated Systems Laboratory, Switzerland

MoD4-3 17:30 - 17:45
Selective-area growth of InGaAs/InP/InAlAs/InP core-multishell nanowires on Si and tunneling transistor application

Katsuhiro Tomioka,^{1,2} Fumiya Ishizaka,¹ Junichi Motohisa,¹ and Takashi Fukui¹

¹Graduate School of Information Science and Technology, and Research Center for Integrated Quantum Electronics (RCIQE), Hokkaido University, Japan, ²JST-PRESTO, Japan

MoD4-4 17:45 - 18:00

Structural and Electrical Properties of GaAs/InSb Core-Shell Nanowires

Mihail Ion Lepsa,^{1,2} Torsten Rieger,^{1,2} Patrick Zellekens,^{1,2} Franz Josef Hackemüller,^{1,2} Thomas Schäpers,^{1,2} and Detlev Grützmacher^{1,2}

¹Peter Grünberg Institute (PGI-9), Forschungszentrum Jülich GmbH, Germany, ²Jülich Aachen Research Alliance for Fundamentals of Future Information Technology (JARA-FIT), Germany

MoD4-5 18:00 - 18:15

Electrical characteristic of n-InP/ i-GaInAs/ p-InP core-multishell NWs grown by self-catalytic VLS mode

Keita Asakura, Takehiro Ogino, Kohei Takano, Takao Waho, and Kazuhiko Shimomura

Sophia University, Department of Engineering and Applied Sciences, Japan

MoD4-6 18:15 - 18:30

Vertical III–V Nanowire Transistors and CMOS Circuits on Si

Johannes Svensson, Anil Dey, Daniel Jacobsson, and Lars-Erik Wernersson

Lund University, Sweden

MoP Poster Session

Reception Hall 18:30-20:30

MoP-ISCS-LN-1

Circular Photogalvanic effect in CdSe Nanowires at Room Temperature

Ning Tang, Shan Zhang, Junxi Duan, Xin He, Lun Dai, Weikun Ge, and Bo Shen

State Key Laboratory of Artificial Microstructure and Mesoscopic Physics, School of Physics, Peking University, China

MoP-ISCS-LN-2

Observation of Hofstadter butterfly and valley Hall effect in hBN/graphene/hBN heterostructures

Katsuyoshi Komatsu,^{1,2} Eiichiro Watanabe,² Daiju Tsuya,² Kenji Watanabe,² Takashi Taniguchi,² and Satoshi Moriyama²

¹Tokyo Institute of Technology, Japan, ²National Institute for Materials Science, Japan

MoP-ISCS-LN-3

Ultraviolet GaN-based Light-Emitting Diodes with an Embedded porous-AlGaN Reflectors

Chia-Feng Lin, Zun-Yao Syu, and Zhong-Jie Yang

Department of Materials Science and Engineering, National Chung Hsing University, Taiwan

MoP-ISCS-LN-4

Electrical Damage Investigation of n-GaN Films Treated by CF₄ Plasma

Yoshitaka Nakano,¹ Masahito Niibe,² and Retsuo Kawakami³

¹Chubu University, Japan, ²University of Hyogo, Japan, ³Tokushima University, Japan

MoP-ISCS-LN-5

Optical Properties of nanoporous GaN structure transformed from GaN epitaxial layer

Chia-Feng Lin, Guo-Yi Shiu, and Wei-Ju Hsu

Department of Materials Science and Engineering, National Chung Hsing University, Taiwan

MoP-ISCS-LN-6

Fabrication and Improved Performance of AlGaIn/GaN HEMTs with Regrown Ohmic Contacts and Passivation-First Process

Tongde Huang,¹ Chao Liu,² Johan Bergsten,¹ Huaxing Jiang,² Kei May Lau,² and Niklas Rorsman¹

¹*Department of Microwave Technology, Chalmers University of Technology, S-412 96 Göteborg, Sweden, Sweden,*

²*Department of Electronic and Computer Engineering, Hong Kong University of Science and Technology, Clear Water Bay, Kowloon, Hong Kong., Hong Kong*

MoP-ISCS-LN-7

Dilute-Nitride GaNP Planar and Core/Shell Microwire Solar Cells

Supanee Sukrittanon,¹ Ren Liu,² Janet L Pan,² Katherine L Jungjohann,³ Shadi A Dayeh,^{1,2} and Charles W Tu^{1,2}

¹*Graduate Program of Materials Science and Engineering, University of California, San Diego, United States of America,*

²*Department of Electrical and Computer Engineering, University of California, San Diego, United States of America,* ³*Center for Integrated Nanotechnologies, Sandia National Laboratories, United States of America*

MoP-IPRM-LN-1

Analysis of Antenna-Integrated Resonant Tunneling Diodes and its Modulation by using Adjacent Photodiodes for Wireless Transmitters in Radio over Fiver Technology

Naoto Okumura,¹ Kiyoto Asakawa,² and Michihiko Suhara¹

¹*Electrical and Electronic Engineering, Graduate School of Science and Engineering, Tokyo Metropolitan University, Japan,*

²*Electronics and Information Engineering Course, Tokyo Metropolitan College of Industrial Technology, Japan*

MoP-IPRM-LN-2

High-Current InP-Based Triple Heterojunction Tunnel Transistors

Pengyu Long,¹ Jun Z Huang,¹ Michael Povolotskyi,¹ Devin Verreck,^{1,3} Gerhard Klimeck,¹ and Mark. J.W. Rodwell²

¹*Network for computational nanotechnology, Purdue University, West Lafayette, IN 47906, United States of America,* ²*ECE*

Department, University of California, Santa Barbara, CA 93106-95603, United States of America, ³*Department of Electrical Engineering, imec, KU Leuven, 3001 Leuven, Belgium, Belgium*

MoP-IPRM-LN-3

Photovoltaic Properties of Perovskite-type Solar Cells with Polysilane-doped Hole Transport Layers

Yasuhiro Shirahata,¹ Yuki Yamamoto,¹ Atsushi Suzuki,¹ Takeo Oku,¹ Sakiko Fukunishi,² and Kazufumi Kohno²

¹*The University of Shiga Prefecture, Japan,* ²*Osaka Gas Chemicals Co., Ltd, Japan*

MoP-ISCS-001

Two-Wavelength Excited Photoluminescence in 4H-SiC Substrate -Dependence on BGE Power Density-

Keitaro Kondo, Norihiko Kamata, Shuhei Yagi, Hiroyuki Yaguchi, Takeshi Fukuda, and Zentaro Honda

Department of Functional Materials Science, Saitama University, Japan

MoP-ISCS-002

Photoresponse measurement of highly oriented BaSi₂ films on Ge(111) using solid phase epitaxy templates

Ryota Takabe, Kaoru Toko, and Takashi Suemasu

University of Tsukuba, Japan

MoP-ISCS-003

Effect of growth condition of buffer layer for heteroepitaxial InSb films grown on Ge(111) substrate

Takaaki Mitsueda, Masayuki Mori, and Koichi Maezawa

Graduate School of Science and Engineering, University of Toyama, Japan

MoP-ISCS-004

Effects of Ga deposition rate and antimony flux on morphology of GaSb quantum dots formed on GaAsTakuya Kawazu,¹ Takeshi Noda,¹ Yoshiki Sakuma,¹ and Hiroyuki Sakaki^{1,2}¹National Institute for Materials Science, Japan, ²Toyota Technological Institute, Japan

MoP-ISCS-005

Growth of GaSb Dots Nucleation Layer and Thin-Film GaSb on Si(100) Substrate by Molecular Beam EpitaxyRyuto Machida,¹ Ryusuke Toda,¹ Sachie Fujikawa,¹ Shinsuke Hara,² Issei Watanabe,² Kouichi Akahane,² Akifumi Kasamatsu,² and Hiroki I. Fujishiro¹¹Tokyo University of Science, Japan, ²National Institute of Info. & Com. Tech. (NICT), Japan

MoP-ISCS-006

Heteroepitaxial growth of InGaSb on GaSb/Si(111)- $\sqrt{3}\times\sqrt{3}$ -Ga surface phase with two step growth method

A. A. Mohammad Monzur-Ul-Akhir, Masayuki Mori, and Koichi Maezawa

Nano&Functional Material Sciences, Graduate School of Science & Engineering, University of Toyama, Gofuku, Japan, Japan

MoP-ISCS-007

Metalorganic Vapor Phase Epitaxy of GaPN alloys Assisted by Surface nitridation with ammoniaKerlee Boualiong,¹ Keisuke Yamane,¹ Masashi Moriyama,¹ Hiroto Sekiguchi,¹ Hiroshi Okada,^{1,2} and Akihiro Wakahara^{1,2}¹Department of Electrical and Electronic Information Engineering, Toyohashi University of Technology, Japan, ²Electronics-inspired Interdisciplinary Research Institute, Toyohashi University of Technology, Japan

MoP-ISCS-008

Growth and characterization of (Zn, Sn, Ga)As₂ thin films grown on GaAs(001) substrate by molecular beam epitaxy

Hideyuki Toyota, Tatsuya Terauchi, Shiro Hidaka, Takahiro Kato, and Naotaka Uchitomi

Department of Electrical Engineering, Nagaoka University of Technology, Japan

MoP-ISCS-009

Temperature Dependence of Photoluminescence Properties of Zinc Sulfide Grown from Aqueous Solutions by Mist Chemical Vapor Deposition

Kazuyuki Uno, Yasuyuki Asano, Yuichiro Yamasaki, and Ichiro Tanaka

Wakayama University, Japan

MoP-ISCS-010

Pressure control for the preparation of the large diameter InP crystal by LEC method after in-situ P injection synthesisShujie Wang,¹ Niefeng Sun,¹ Yingkuan Han,^{1,2} Xiaolan Li,¹ Huimin Shao,¹ Yanlei Shi,¹ Yang Wang,¹ Lijie Fu,¹ Huisheng Liu,¹ Ruixia Yang,² and Tongnian Sun¹*¹National Key Laboratory of Asic, Hebei Semiconductor Research Institute, China, ²School of Information Engineering, Hebei University of Technology, China*

MoP-ISCS-011

Evaluation of Etched Pits on InP Substrates by White-light InterferenceYingkuan Han,^{1,2} Ruixia Yang,² Niefeng Sun,¹ Shujie Wang,¹ Xiaolan Li,¹ Huimin Shao,¹ Yanlei Shi,¹ Yang Wang,¹ Lijie Fu,¹ Huisheng Liu,¹ and Tongnian Sun¹*¹National Key Laboratory of Asic, Hebei Semiconductor Research Institute, China, ²School of electronic and information engineering, Hebei University of Technology, China*

MoP-ISCS-012

The growth process analysis of the ZnTe layer on the m-plane sapphire substrate with nano-facet structuresTaizo Nakasu,¹ Takaru Kizu,¹ Wei-Che Sun,¹ Fukino Kazami,¹ Masakazu Kobayashi,^{1,2} and Toshiaki Asahi³*¹Department of Electrical Engineering and Bioscience, Waseda University, Japan, ²Kagami Memorial Research Institute for Materials Science and Technology, Waseda University, Japan, ³Technology Development Group, JX Nippon Mining & Metals Corporation, Japan*

MoP-ISCS-013

Local distribution of the material composition in the V-defect region of HgCdTe epitaxial filmsMaxim Yakushev,² Vadim Novikov,¹ Denis Grigoryev,¹ Dmitriy Bezrodnyy,¹ and Sergei Dvoretzky^{1,2}*¹Department of Radio Physics, National Research Tomsk State University, Russia, ²Laboratory of Epitaxial Technology from Molecular Beams of A2B6 Compounds, Institute of Semiconductor Physics, Russia*

MoP-ISCS-014

Growth and Solar Cell Applications of AgGaTe₂ layers by Closed Space Sublimation using the Mixed Source of Ag₂Te and Ga₂Te₃Aya Uruno,¹ Shinichiro Kikai,¹ Yuri Suetsugu,¹ and Masakazu Kobayashi^{1,2}¹Department of Electrical Engineering and Bioscience, Waseda University, Japan, ²Kagami Memorial Research Institute for Materials Science and Technology, Waseda University, Japan

MoP-ISCS-015

Demonstration of RF-DC conversion using dual diode rectifier circuit for rectenna with diamond Schottky barrier diodes

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MoP-ISCS-016

Design of DC-DC Buck Converter with Integrated Over-current Protection based on Power AlGaIn/GaN MIS-HEMT ConfigurationRuize Sun,^{1,2} Yung C. Liang,^{1,2} Yee-Chia Yeo,¹ Yun-Hsiang Wang,¹ and Cezhou Zhao³¹Dept of Electrical and Computer Engg, National University of Singapore, Singapore, ²National University of Singapore (Suzhou) Research Institute, China, ³Dept of Electrical and Electronic Engg, Xi'an Jiaotong-Liverpool University, China

MoP-ISCS-017

Low-frequency noise exponents in InAs thin films on flexible or GaAs(001) substrates

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MoP-ISCS-018

Demonstration of InGaAs FETs on quartz glass toward terahertz applicationsEiji Kume,¹ Hiroyuki Ishii,² Hiroyuki Hattori,² Wen-Hsin Chang,² Mutsuo Ogura,¹ and Tatsuro Maeda²¹IRspec Corporation, Japan, ²Nanoelectronics Research Institute, National Institute of Advanced Industrial Science and Technology, Japan

MoP-ISCS-019

Modeling edge capacitances in ultra-scaled GaAs Schottky barrier diodes for THz applicationsDiego Moro-Melgar,¹ Alain Maestrini,¹ Jeanne Treuttel,¹ Tomás González,² Beatriz G. Vasallo,² and Javier Mateos²¹Observatory of Paris (LERMA), France, ²University of Salamanca, Spain

MoP-ISCS-020

Enhancement-Mode GaN MIS-HEMTs with HfLaO_x Gate InsulatorY. C. Lin,¹ J. C. Lin,¹ Y. Lin,¹ C. H. Wu,¹ Y. X. Huang,¹ S. C. Liu,¹ H. T. Hsu,² T. E. Hsieh,¹ K. Kakushima,³ H. Iwai,^{2,3} and E. Y. Chang^{1,2}¹Department of Materials Science & Engineering, National Chiao-tung University, Taiwan, ²International College of Semiconductor Technology, National Chiao-tung University, Taiwan, ³Interdisciplinary Graduate School of Science and Engineering, Tokyo Institute of Technology, Japan

MoP-ISCS-021

The Effect of Surface Passivation on the Electrical Performance of AlGaIn/GaN HEMTs with Slant Field PlatesHeng-Tung Hsu,¹ Yueh-Chin Lin,² Lu-Che Huang,² Chia-Hua Chang,² Ting-En Hsieh,² Yasushi Itoh,³ and Edward Yi Chang^{1,2}

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MoP-ISCS-022

Current Collapse Suppression by SiO₂ Passivation in p-GaN/AlGaIn/GaN Enhancement-Mode High Electron Mobility Transistors

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MoP-ISCS-023

Evaluation of GaN HEMT with Field Plate for Reliability ImprovementY. C. Lin,¹ J. C. Lin,¹ Y. Lin,¹ C. H. Wu,¹ P. C. Chin,¹ H. T. Hsu,² T. E. Hsieh,¹ H. Iwai,^{2,3} and E. Y. Chang^{1,2}

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MoP-ISCS-024

AlGaIn/GaN Metal-Oxide-Semiconductor High-Electron-Mobility Transistors with TiO₂ Gate Dielectrics

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MoP-ISCS-025

Output Characteristics of GaAs Photoconductive Semiconductor Switch at High Bias VoltagesYong-Pyo Kim,¹ Jiheon Ryu,² Sung Hyun Baek,² Sung-Min Hong,¹ Sungbae Lee,³ and Jae-Hyung Jang¹

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MoP-ISCS-026

Two-dimensional electron gas in MgZnO/ZnO heterostructures grown by dual-ion beam sputteringRohit Singh,^{1,2} Md Arif Khan,^{1,2} Abhinav Kranti,² and Shaibal Mukherjee¹

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MoP-ISCS-027

Noise Investigation of DFB Laser Diodes Operating at 894 nm for Compact Commercial Cesium Atomic ClocksNicolas von Bandel,¹ Mikhael Myara,² Philippe Signoret,² Michel Garcia,¹ Alexandre Larrue,¹ Olivier Parillaud,¹ and Michel Krakowski¹¹III-V Lab, France, ²Institut d'Electronique et des Systèmes, University of Montpellier, France

MoP-ISCS-028

Monolithic integration and epitaxial gain control of GaAs-based nanowire lasers on Si

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Walter Schottky Institut, Technical University Munich, Germany

MoP-ISCS-029

Comprehensive Analysis on Electrically Pumped Metallic Cavity Lasers

Chuanqing Yu, Baifu Zhang, Yi Xiao, Takuo Tanemura, and Yoshiaki Nakano

Department of Electrical Engineering and Information Systems, The Univ of Tokyo, Japan

MoP-ISCS-030

Numerical Demonstration of the Feasibility of the Current Driven Photonic Crystal Laser Diode Used for Wavelength Division Multiplexing

Yifan Xiong, Tomoyuki Okada, Xiuyu Zhang, Masato Morifuji, and Masahiko Kondow

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MoP-ISCS-031

GaAs-based 2-dimensional photonic crystal slab with large r/a used for wavelength-division multiplexing

Xiuyu Zhang, Kentaro Hashimura, Yuta Imada, Takahumi Hino, Tomoyuki Okada, Masato Morifuji, and Masahiko Kondow

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MoP-ISCS-032

A Novel Deep Guard-ring InGaAs PIN Photodiode Structure Reducing a Crosstalk in SWIR Imaging Detection

Inseob Noh, Hyungjun Noh, Youngjun Kim, Kiwon Lee, and Kyounghoon Yang

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MoP-ISCS-033

Two-Color Lasing from a GaAs/AlGaAs Coupled Multilayer Cavity by Current Injection

Hiroto Ota, Xiangmeng Lu, Naoto Kumagai, Takahiro Kitada, and Toshiro Isu

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MoP-ISCS-034

GaAs/AlAs triple-coupled cavity with InAs quantum dots for ultrafast wavelength conversion devices

Xiangmeng Lu, Kumagai Naoto, Takahiro Kitada, and Toshiro Isu

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MoP-ISCS-035

Simultaneous lasing at ground and excited states in InAs/GaAs quantum dot laser diodes due to inhomogeneous broadeningJong Min Lee,¹ Jungho Kim,² and Donghan Lee¹*¹Department of Physics, Chungnam National University, Republic of Korea, ²Department of Information Display, Kyung Hee University, Republic of Korea*

MoP-ISCS-036

Polarization anisotropy of electroluminescence and net-modal gain in highly stacked InAs/GaAs quantum-dot laser devices

Toshiyuki Kaizu, Masaya Suwa, Takaya Andachi, Yukihiro Harada, and Takashi Kita

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MoP-ISCS-037

Emission wavelength variation of InAs quantum dots grown on GaAs using As₂ molecules in molecular beam epitaxyYuma Hayashi,¹ Nobuhiko Ozaki,¹ Shunsuke Ohkouchi,² Hirotaka Ohsato,³ Eiichiro Watanabe,³ Naoki Ikeda,³ and Yoshimasa Sugimoto³*¹Wakayama Univ, Japan, ²NEC Corp., Japan, ³National Institute for Materials Science, Japan*

MoP-ISCS-038

Selective Doping in InAs/GaAs Quantum Dot Solar Cells: Effect on Photoluminescence and Photovoltaic Performance

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MoP-ISCS-039

Study of Light-Trapping Enhanced Quantum Dot Solar Cells based on Electrical and Optical Numerical Simulations

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MoP-ISCS-040

Colloidal Quantum Dot Photonic Crystal Lasers with M-point Band-edge EmissionHojun Chang,^{1,2} Kyungtaek Min,^{1,2} Myungjae Lee,^{1,2} Minsu Kang,^{1,2} Yeonsang Park,³ Kyung Sang Cho,³ Young-Geun Roh,³ Sungwoo Hwang,³ and Heonsu Jeon^{1,2}*¹Department of Physics and Astronomy, Seoul National University, Republic of Korea, ²Inter-university Semiconductor Research Center, Seoul National University, Republic of Korea, ³Samsung Advanced Institute of Technology, Republic of Korea*

MoP-ISCS-041

Impact of Antiphase Boundaries on Non-linear Frequency Conversion in GaP/Si MicrodisksPierre Guillemé,¹ Charles Cornet,¹ Antoine Létoublon,¹ Julien Stodolna,² Yannick Dumeige,¹ Julie Le Pouliquen,¹ Patrice Féron,¹ Anne Ponchet,² Olivier Durand,¹ and Yoan Léger¹*¹UMR Foton, CNRS, INSA Rennes, Université de Rennes 1, France, ²CEMES-CNRS, Université de Toulouse, UPS, France*

MoP-ISCS-042

MBE Deep-UV LEDs on Bulk AlN SubstratesSm Moudud Islam,¹ Vladimir Protasenko,¹ Huili (Grace) Xing,² and Debdeep Jena²¹Department of ECE, Cornell University, United States of America, ²Department of ECE and MSE, Cornell University, United States of America

MoP-ISCS-043

Monolithically integrated GaN-based HEMT-LED and InGaN/GaN photodiodes for on-chip optical interconnects

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MoP-ISCS-044

AlN/ITO hybrid electrodes with conducting filament for 365 nm ultraviolet light-emitting diodes

Kyeong Heon Kim, Tae-Ho Lee, Byeong Ryong Lee, Kyung Rock Son, Dae Yun Kang, Ju Hyun Park, Sin Hwan Choi, Dong Su Jeon, Myung Ju Kim, Tae Hun Park, and Tae Geun Kim

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MoP-ISCS-045

Electronic Structures Calculation of Si_{1-x}Sn_x Compound Alloy Using Interacting Quasi-band Model

Masato Oda, Yukina Kuroda, Ayaka Kishi, and Yuzo Shinozuka

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MoP-ISCS-046

Band alignment study and plasmon generation at dual ion-beam sputtered Ga:ZnO/Ga:MgZnO heterojunction interfaceVishnu Awasthi,¹ Vivek Garg,¹ Brajendra S. Sengar,¹ Rohit Singh,¹ Sushil K Pandey,² Shailendra Kumar,³ C. Mukherjee,⁴ and Shaibal Mukherjee¹¹Hybrid Nanodevice Research Group (HNRG), Electrical Engineering, Indian Institute of Technology, India, ²Department of Electrical Engineering, Indian Institute of Technology Bombay, India, ³Indus Synchrotron Utilization Division, Raja Ramanna Center for Advanced Technology, India, ⁴Laser System Engineering Division, Raja Ramanna Center for Advanced Technology, India

MoP-ISCS-047

Growth of ZnO and Indium-doped ZnO Structures for Dye-sensitized Solar CellsYa-Fen Wu,¹ Hung-Pin Hsu,¹ Wei-You Chen,¹ and Jiunn-Chyi Lee²¹Department of Electronic Engineering, Ming Chi University of Technology, Taiwan, ²Department of Electrical Engineering, Taipei City University of Science and Technology, Taiwan

MoP-ISCS-048

Fabrication and Characterization of A Multiple Gate Nanowire FET for Detecting Spatially Distributed Molecular ChargesKentaro Sasaki,¹ Ryota Kuroda,¹ Xiang Yin,¹ Masaki Sato,¹ Takuji Ogawa,² and Seiya Kasai¹¹Research Center for Integrated Quantum Electronics and Graduate School of Information Science & Technology, Hokkaido University, Japan, ²Graduate School of Science, Osaka University, Japan

MoP-ISCS-049

Shubnikov-de Haas Oscillations Observed in High-Mobility Monolayer Graphene Encapsulated by h-BNMasaaki Mineharu,¹ Masahiro Matsunaga,¹ Naoki Matsumoto,¹ Carlo da Cunha,² Chiashain Chuang,¹ Yuichi Ochiai,¹ Inyeal Lee,³ Gil-Ho Kim,³ Kenji Watanabe,⁴ Takashi Taniguchi,⁴ David K. Ferry,⁵ Jonathan P. Bird,⁶ and Nobuyuki Aoki¹

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MoP-ISCS-050

Investigation of Spin Dynamics Based on Initial Phase Shift Analysis of Kerr Rotation in a CdTe Single Quantum Well

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MoP-ISCS-051

Magnetic moment in Diluted Magnetic Semiconductor GaGdAs measured by HX-MCDHayato Miyagawa,¹ Nakaba Funaki,¹ Shyun Koshiba,¹ Naoshi Takahashi,² Masaichiro Mizumaki,² and Motohiro Suzuki¹*¹Kagawa University, Japan, ²SPRING-8/JASRI, Japan*

MoP-ISCS-052

Quantum interference of three LO modes in p-type Ga_{0.5}In_{0.5}P : Contribution of a trigonal phonon mode

Hironori Sakamoto, Bei Ma, Ken Morita, and Yoshihiro Ishitani

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MoP-ISCS-053

Picoseconds carrier spin relaxation in In_{0.8}Ga_{0.2}As/Al_{0.5}Ga_{0.5}As/AlAs_{0.56}Sb_{0.44} coupled double quantum wellsTomoki Ishikawa,¹ Shin-ichiro Gozu,² Teruo Mozume,² Masaki Asakawa,¹ Shunsuke Ohki,¹ and Atsushi Tackeuchi¹*¹Department of Applied Physics, Waseda University, Japan, ²National Institute of Advanced Industrial Science and Technology (AIST), Japan*

MoP-ISCS-054

Anomalous Temperature Dependence of Magnetic Properties in Mn-doped ZnSnAs₂ Epitaxial Thin Films

Shiro Hidaka, Hideyuki Toyota, and Naotaka Uchitomi

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MoP-ISCS-055

Growth and doping control of Ge/Si and Si/Ge core-shell nanowiresKotaro Nishibe,¹ Wipakorn Jevasuwan,¹ Masanori Mitome,¹ Yoshio Bando,¹ Zhong Lin Wang,² and Naoki Fukata¹*¹National Institute for Materials Science, Japan, ²Georgia Institute of Technology, United States of America*

MoP-ISCS-056

Thermal current-induced charge redistribution in wide CVD-grown graphene constrictionChiashain Chuang,¹ Tak-Pong Woo,^{2,3} Fan-Hung Liu,⁴ Masahiro Matsunaga,¹ Yuichi Ochiai,¹ Chi-Te Liang,^{2,4} and Nubuyuki Aoki¹

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MoP-ISCS-057

One hundred picosecond spin relaxation in GaAs/GaAsP strain-compensated superlattice as highly spin-polarized electron sourceShunsuke Ohki,¹ Xiuguang Jin,² Masaki Asakawa,¹ Tomoki Ishikawa,¹ and Atsushi Tackeuchi¹

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MoP-ISCS-058

Enhanced Spin Polarization at n-MnSb(0001)/InP(111) Interface

Ebiyibo Collins Ouserigha, Haiyuan Wang, Christopher W Burrows, and Gavin R Bell

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MoP-ISCS-059

Fabrication and Characterization of InGaAs Fin Structure High Electron Mobility TransistorsChia-Ming Chang,¹ Li-Cheng Chang,² and Chao-Hsin Wu^{1,2}

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MoP-ISCS-060

Sheet Electron Density Dependence of Electron Mobility Anisotropy in In_{0.75}Ga_{0.25}As/InP Two-Dimensional Electron Gas

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MoP-ISCS-061

Monopole charge in Weyl semimetals and weak (anti-)localization effect

Hai-Zhou Lu

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MoP-ISCS-062

Influence of MBE Growth Parameters on Film Properties of ZnSnAs₂:Mn Thin Films on InP Substrates

Masaki Ogo, Kenso Takahashi, Shiro Hidaka, Hideyuki Toyota, Takahiro Kato, and Naotaka Uchitomi

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MoP-ISCS-063

Impact of film thickness on crystalline and magnetic properties in Mn-doped ZnSnAs₂ thin films

Tomohiro Kitazawa, Kei Itagaki, Hideyuki Toyota, Takahiro Kato, Shiro Hidaka, and Naotaka Uchitomi

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MoP-ISCS-064

Dependence of Locally Thicker Thin Film Formation by Partial Heating of a Polymer Solution Film on the Substrate from the Bottom during Drying on Latent Heat of Vaporization

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School of Medicine, Fujita Health University, Japan

MoP-ISCS-065

Characterization of In-plane Gate Transistors with Different Geometries

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MoP-ISCS-066

Reduction of thermal conductivity in periodic silicon nanostructures

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MoP-ISCS-067

Flexible Ultraviolet Photodetector made from ZnO Nanowires Synthesized by Direct Ultraviolet-light Decomposition Process

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MoP-ISCS-068

Morphology control of Ag-Te nanostructures by seed silver nanoparticles

Yusuke Imanishi and Toshihiro Nakaoka

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MoP-ISCS-069

Resistive-Switching Crossbar Memory Based on Si₃N₄/SiO₂ Bi-Layer Structure and Copper Chemical Displacement Technique

Li-Min Lin,¹ Ming-Fang Kao,² and Yu-Hsien Lin³

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MoP-ISCS-070

Two-Dimensional Energy Dispersion in Thermally Annealed Epitaxial Nitrogen Atomic Sheet in GaAs

Yasuhiro Ogawa, Yukihiro Harada, Kaizu Toshiyuki, and Takashi Kita

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MoP-ISCS-071

Characterization of Anti-Phase Boundaries at a GaP/Si(001) Cross-Sectional Surface on the Atomic ScaleChristopher Prohl,¹ Henning Doescher,² Peter Kleinschmidt,³ Thomas Hannappel,³ and Andrea Lenz¹¹*Institut für Festkörperphysik, Technische Universität Berlin, Germany,* ²*WZfM, Philipps Universität Marburg, Germany,*³*Institut für Physik, Technische Universität Ilmenau, Germany*

MoP-ISCS-072

Surface X-ray diffraction during GaAs/MnSb/Ga(In)As epitaxial growthPhilip Mousley,¹ Christopher Burrows,¹ Takuo Sasaki,² Masamitsu Takahashi,² and Gavin Bell¹¹*Department of Physics, University of Warwick, United Kingdom,* ²*Quantum Beam Science Center, Japan Atomic Energy Agency, Japan*

MoP-ISCS-073

Selective growth of high crystalline quality In_{0.71}Ga_{0.29}As fin inside nano-trenches by composition graded InGaP buffer for novel CMOS integrationShih-Pang Chang,¹ Kun-Lin Lin,¹ Chien-Ting Wu,¹ Mon-Yang Chen,² Rong-Ren Lee,² Wen-Da Hsu,¹ Shih-Hong Chen,¹ Chun-Jung Su,¹ Guang-Li Luo,¹ Shih-Chang Lee,² Ta-Cheng Hsu,² Jen-Inn Chyi,³ and Wen-Kuan Yeh¹¹*National Nano Device Laboratories, Narlabs., Hsinchu, Taiwan,* ²*Epistar Corporation, Taiwan,* ³*National Central University, Zhongli, Taiwan*

MoP-ISCS-074

Dielectric oxides grown by atomic layer deposition (ALD) on single-crystal (In)GaAs surfaces studied by synchrotron radiation photoemissionTun-Wen Pi,¹ T. D. Lin,² K. Y. Lin,² Y. H. Lin,² H. W. Wan,² Y. H. Chang,² J. Kwo,³ and M. Hong²¹*National Synchrotron Radiation Research Center, Taiwan,* ²*Graduate Institute of Applied Physics and Department of Physics, National Taiwan University, Taiwan,* ³*Department of Physics, National Tsing Hua University, Taiwan*

MoP-ISCS-075

Electrical conductivity of the biaxially-strained GaSb(111) films

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MoP-ISCS-076

Atomic Structure and Electronic States of InAs(Sb)/GaAs Submonolayer Quantum Dots

Andrea Lenz, Zeno Diemer, Christopher Prohl, David Quandt, André Strittmatter, Udo W. Pohl, and Holger Eisele

Technische Universität Berlin, Germany

MoP-ISCS-077

InAs/InAlAsSb quantum nanostructures grown on InP substrate for intermediate band solar cell application

Yasushi Shoji, Nazmul Ahsan, Ryo Tamaki, and Yoshitaka Okada

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MoP-ISCS-078

Electron Eigen-States in InGaAs/InAlAs Multi-Quantum Wells Using Photocurrent Spectroscopy

Koichi Tanaka,¹ Naohisa Happo,¹ Makoto Fujiwara,¹ and Nobuo Kotera²

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MoP-ISCS-079

Structural characterization for GaAs nanowires Au-assisted grown by pulsed-jet gas epitaxy measured using Raman spectroscopy

Hiroki Yoshidome,¹ Kouji Maeda,¹ Kenji Kamimura,¹ Goushi Nakagawa,¹ Hidetoshi Suzuki,¹ and Kentaro Sakai²

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MoP-ISCS-080

Development of c-Plane Thin-Film Flip-Chip LEDs Fabricated by Photoelectrochemical (PEC) Liftoff

David Hwang,¹ Benjamin Yonkee,¹ Robert M. Farrell,¹ Shuji Nakamura,^{1,2} James S. Speck,¹ and Steven P. DenBaars^{1,2}

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MoP-ISCS-081

Origin of Unintentional Gallium Incorporation into AlN Layers Grown by Metalorganic Vapor Phase Epitaxy

Atsushi Yamada, Tetsuro Ishiguro, Junji Kotani, Shuichi Tomabechi, and Norikazu Nakamura

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MoP-ISCS-082

Tunnel junction devices with monolithic optically pumped and electrically injected InGaN quantum wells for polarized white light emission

Stacy Kowsz,¹ Christopher Pynn,¹ Robert Farrell,¹ James Speck,¹ Steven DenBaars,^{1,2} and Shuji Nakamura¹

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MoP-ISCS-083

Relationship between Al content of AlGa_N buffer layer on top of initial AlN nucleation layer on Si and vertical leakage current of AlGa_N/Ga_N high-electron-mobility transistor structures

Yuya Yamaoka,^{1,2} Kazuhiro Ito,² Akinori Ubukata,¹ Yoshiki Yano,¹ Toshiya Tabuchi,¹ Koh Matsumoto,¹ and Takashi Egawa²

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MoP-ISCS-084

Optical Characterization of Carrier Recombination Processes in GaPN by Two-Wavelength Excited Photoluminescence

Makiko Suetsugu,¹ Norihiko Kamata,¹ Shuhei Yagi,¹ Hiroyuki Yaguchi,¹ Takeshi Fukuda,¹ Fredrik Karlsson,² and Per-Olof Holtz²

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MoP-ISCS-085

Self-Organized Growth of Cubic InN Dot Arrays on MgO (001) Vicinal Substrates

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MoP-ISCS-086

Si_N_x Passivated GaN HEMT by Plasma Enhanced Atomic Layer Deposition

Takayuki Suzuki, Tomiaki Yamada, Ryosuke Kawai, Shohei Kawaguchi, Dongyan Zhang, and Naotaka Iwata

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MoP-ISCS-087

Band Alignment between High-k ZrO₂ and Wide Bandgap Semiconductors: GaN, AlN and SiC

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MoP-ISCS-088

Crystallographic Properties of 3d Transition Metal (Ti, V, and Cr) doped AlN films

Nobuyuki Tatemizo, Saki Sonoda, Koji Nishio, and Toshiyuki Isshiki

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MoP-ISCS-089

Improvement of Crystalline Quality of AlN and High-Al-content AlGa_N at High Growth Rate Using Horizontal High-flow-rate MOVPE System

Kazutada Ikenaga, Akira Mishima, Yoshiki Yano, Toshiya Tabuchi, and Koh Matsumoto

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MoP-ISCS-090

Non-radiative Recombination Centers in AlGa_N Quantum Well Characterized by Two-Wavelength Excited PhotoluminescenceMd Julkarnain,^{1,2} Takeshi Fukuda,¹ Norihiko Kamata,¹ and Hideki Hirayama³¹Department of Functional Materials Science, Saitama University, Japan, ²Department of Applied Physics and Electronic Engineering, University of Rajshahi, Bangladesh, ³Quantum Optodevice Laboratory, RIKEN, Japan

MoP-ISCS-091

Low-threshold Ultraviolet emission from AlGa_N based lasers grown on trench-patterned AlN/sapphire template

Xiang Chen, Jianchang Yan, Yun Zhang, Yingdong Tian, Yanan Guo, Junxi Wang, and Jinmin Li

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MoP-ISCS-092

First principles study of carbon diffusion in GaN

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MoP-ISCS-093

Influence of p-type Doping on GaN Junction Barrier Schottky Diode with Array PillarShao-Yen Chiu,¹ Chih-Wei Yang,¹ Yu-Li Wang,² Wei-Chen Yang,² Yu-Teng Tseng,² and Keh-Yung Cheng²¹Episil Technologies Inc., Taiwan, ²National Tsing Hua University, Department of Electrical Engineering, Taiwan

MoP-ISCS-094

Electronic States of III-V and II-VI Alloys Calculated by IQB Theory

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Wakayama University, Japan

MoP-ISCS-095

Reduction of Threshold Voltage Instability in Recessed-gate AlGa_N/Ga_N MOSHEMTs by KOH PassivationTzung-Han Tsai,¹ Min Yang,¹ Li-Cheng Chang,¹ and Chao-Hsin Wu^{1,2}¹Graduate Institute of Electronic and Engineering, National Taiwan University, Taiwan, ²Graduate Institute of Photonics and Optoelectronics, National Taiwan University, Taiwan

MoP-ISCS-096

Effect of Ultraviolet Light-Assisted CF₄ Plasma Irradiation on AlGa_N Thin Film SurfaceRetsuo Kawakami,¹ Masahito Niibe,² Yoshitaka Nakano,³ and Takashi Mukai⁴¹Tokushima University, Japan, ²University of Hyogo, Japan, ³Chubu University, Japan, ⁴Nichia Corporation, Japan

MoP-ISCS-097

Effect of Nonuniform Current Injection on Electroluminescence Spectra of InGa_N-Ga_N Blue-Green Light-Emitting DiodeIrina Khmyrova,¹ Yulia Kholopova,² Sergey Larkin,² Valery Zemlyakov,³ Bogdan Shevchenko,⁴ Andrei Tsatsul'nikov,⁵ and Sergei Shapoval²¹University of Aizu, Japan, ²IMT RAS, Russia, ³NRUET, Russia, ⁴LETI, Russia, ⁵A. F. Ioffe Physico-Technical Institute RAS, Russia

MoP-ISCS-098

Variations in Photoluminescence Properties of GaN-based Thin Films Directly Grown on an Amorphous Quartz Glass Substrate

Atomu Fujiwara, Shota Ishizaki, Shun Nakane, Yoshifumi Murakami, and Yuichi Sato

Department of Electrical and Electronic Engineering, Akita University, Japan

MoP-ISCS-099

Hall factor for hopping conduction in n- and p-type GaN

Yasutomo Kajikawa

Department of Electric and Control Systems Engineering, Interdisciplinary Faculty of Science and Engineering, Shimane University, Japan

MoP-ISCS-100

Electrical and Optical Properties of Polycrystalline NbO₂ Thin Films Grown by Solid Phase CrystallizationShoichiro Nakao,¹ Hideyuki Kamisaka,² Yasushi Hirose,^{1,2} and Tetsuya Hasegawa^{1,2}*¹Kanagawa Agency of Science and Technology, Japan, ²Department of Chemistry, The University of Tokyo, Japan*

MoP-ISCS-101

SnO₂ Thin Films Grown on *m*-Plane Sapphire Substrate by Mist Chemical Vapor DepositionTatsuya Otabe,¹ Takehide Sato,² Junya Matsushita,² Zenji Yatabe,³ Koji Sue,² Shoji Nagaoka,^{4,5} and Yusui Nakamura^{1,5}*¹Graduate School of Science and Technology, Kumamoto University, Japan, ²Faculty of Engineering, Kumamoto University, Japan, ³Priority Organization for Innovation and Excellence, Kumamoto University, Japan, ⁴Kumamoto Industrial Research Institute, Japan, ⁵Kumamoto Institute for Photo-electro Organics, Japan*

MoP-ISCS-102

Influence of plasma treatments and SnO₂ alloying on the conductive properties of epitaxial Ga₂O₃ films deposited on C-sapphire by chemical vapor depositionAlban Maertens,^{1,2} Samuel Margueron,^{1,2} Frédéric Genty,^{1,2} Adulfas Abrutis,³ Thierry Belmonte,⁴ Pascal Boulet,⁴ Jaafar Ghanbaja,⁴ Abdelkrim Talbi,⁵ and Ausrine Bartasyte⁶*¹Centrale Supélec, France, ²Université de Lorraine, France, ³Department of General and Inorganic Chemistry, University of Vilnius, Lithuania, ⁴Université de Lorraine, Institut Jean Lamour, CNR UMR 7198, France, ⁵Lia LEMAC/LICS - IEMN, EC Lille-CNRS UMR 8520, France, ⁶Femto-ST Institute, CNRS UMR 6174, Université de Franche-comté, France*

MoP-ISCS-103

Improvement of *m*-plane ZnO Films Formed on Buffer Layers on Sapphire Substrates by Mist Chemical Vapor DepositionHironobu Tanoue,¹ Tatsuya Yamashita,¹ Shohei Wada,¹ Zenji Yatabe,² Shoji Nagaoka,^{3,4} and Yusui Nakamura^{1,4}*¹Graduate School of Science and Technology, Kumamoto University, Japan, ²Priority Organization for Innovation and Excellence, Kumamoto University, Japan, ³Kumamoto Industrial Research Institute, Japan, ⁴Kumamoto Institute for Photo-electro Organics, Japan*

MoP-ISCS-104

Effects of oxygen flows and annealing temperature on properties of cosputtering In_2O_3 - Ga_2O_3 -Zn thin filmsYih-Shing Lee,¹ Sheng-Yu Zhao,¹ Yuan-Zhe Lin,² and Glen Andrew Porter³

¹Department of Optoelectronic System Engineering, Minghsin University of Science and Technology, Taiwan, ²Institute of Electronics, Minghsin University of Science and Technology, Xinfeng, Taiwan, ³Department of Electronics Engineering, National Kaohsiung University of Applied Sciences, Taiwan

MoP-ISCS-105

Facile synthesis of Au-decorated ZnO nanorod substrates for visible-light-driven photocatalytic activity and plasmonic luminescence propertiesDa-Ren Hang,¹ Sk Emdadul Islam,¹ Chun-Hu Chen,² and Krishna Hari Sharma¹

¹Department of Materials and Optoelectronic Science, National Sun Yat-sen University, Taiwan, ²Department of Chemistry, National Sun Yat-sen University, Taiwan

MoP-ISCS-106

Surface plasmon resonant emission from Ag dispersed ZnO films fabricated by molecular precursor methodDaichi Taka,¹ Takeyoshi Onuma,¹ Takashi Shibukawa,¹ Hiroki Nagai,¹ Tomohiro Yamaguchi,¹ Ja-Soon Jang,² Mitsunobu Sato,¹ and Tohru Honda¹

¹Kogakuin Univ., Japan, ²Yeungnam Univ., Republic of Korea

MoP-ISCS-107

Time-Resolved Spectroscopy of luminescence in Wide Gap Si Doped β - Ga_2O_3

Hisaya Oda, Nana Kimura, Dai Yasukawa, Hirofumi Wakai, and Akio Yamanaka

Chitose Institute of Science and Technology, Japan

MoP-ISCS-108

Microstructural Analysis of Nb-doped Anatase TiO_2 Transparent Conductive Films by Transmission Electron MicroscopyDaisuke Ogawa,¹ Shoichiro Nakao,² Kazuo Morikawa,¹ Yasushi Hirose,^{2,3} and Tetsuya Hasegawa^{2,3}

¹Tokyo Metropolitan Industrial Technology Research Institute, Japan, ²Kanagawa Agency of Science and Technology, Japan, ³Department of Chemistry, Graduate School of Science, The University of Tokyo, Japan

MoP-ISCS-110

Fabrication and Characterization of BiFeO_3 Thin Films and Application for Photovoltaic Devices

Yasuhiro Shirahata, Atsushi Suzuki, and Takeo Oku

Department of Materials Science, The University of Shiga Prefecture, Japan

MoP-ISCS-111

Low-temperature carrier transport properties of n-type ultrananocrystalline diamond/p-type Si heterojunction diodesAbdelrahman Zkria Ahmed^{1,2} and Tsuyoshi Yoshitake¹

¹Department of Applied Sciences for Electronics & Materials, Kyushu University, Japan, ²Department of Physics, Faculty of Science, Aswan University, Egypt

MoP-ISCS-112

Characterization of Carbon/Carbon Composites Containing Cellulose by ElectrospinningShouta Nakajo,¹ Takuya Murakami,¹ Haruka Shimada,¹ Kozo Osawa,¹ Masahiko Murata,¹ Tomoyuki Itaya,¹ Kyoichi Oshida,¹ Kenji Takeuchi,² and Morinobu Endo²¹National Institute of Technology, Nagano College, Japan, ²ICST, Shinsyu University, Japan

MoP-ISCS-113

Molecular Design of Functionalized Fullerenes and Graphenes: Density Functional Theory (DFT) Study

Hiroto Tachikawa, Tetsuji Iyama, and Hiroshi Kawabata

Hokkaido University, Japan

MoP-ISCS-114

Electronic States of Organic Radical-Functionalized Graphenes and Fullerenes: Density Functional Theory (DFT) Study

Tetsuji Iyama, Hiroshi Kawabata, Takahiro Fukuzumi, and Hiroto Tachikawa

Hokkaido University, Japan

MoP-ISCS-115

Hydrophilic Graphene Film by Molecular Functionalization

Yoshiaki Taniguchi, Tsubasa Miki, Takanori Mitsuno, Yasuhide Ohno, Masao Nagase, Keiji Minagawa, and Mikito Yasuzawa

Graduate School of Advanced Technology and Science, Tokushima University, Japan

MoP-ISCS-116

Epitaxial growth on a dynamically rough substrate: a Monte Carlo model of graphene / Cu(111)Gwilym Enstone,¹ Peter Brommer,² David Quigley,³ and Gavin Bell³¹Centre for Complexity Science, University of Warwick, United Kingdom, ²Centre for Predictive Modelling, University of Warwick, United Kingdom, ³Department of Physics, University of Warwick, United Kingdom

MoP-ISCS-117

Extraction of Intrinsic and Extrinsic Parameters of Graphene Field-Effect Transistor from Its Asymmetric I-V Characteristic

Akira Satou, Gen Tamamushi, Kenta Sugawara, Junki Mitsushio, Victor Ryzhii, and Taiichi Otsuji

Research Institute of Electrical Communication, Tohoku University, Japan

MoP-ISCS-118

Introducing Uniaxial Local Strain to Graphene Encapsulated with hBNHikari Tomori,^{1,2} Rineka Hiraide,¹ Youiti Ootuka,¹ Kenji Watanabe,³ Takashi Taniguchi,³ and Akinobu Kanda¹¹University of Tsukuba, Japan, ²PRESTO-JST, Japan, ³National Institute for Materials Science (NIMS), Japan

MoP-ISCS-119

Intrinsic pH Sensitivity of Graphene Field-Effect Transistors

Takanori Mitsuno, Yoshiaki Taniguchi, Yasuhide Ohno, and Masao Nagase

Graduate School of Advanced Technology and Science, Tokushima University, Japan

MoP-ISCS-120

Local Strain Engineering in Monolayer MoS₂

Wataru Tomita,¹ Katsushi Hashimoto,¹ Ziqian Wang,² Mingwei Chen,² and Yoshiro Hirayama¹

¹Department of Physics, Tohoku University, Japan, ²WPI Advanced Institute for Materials Research, Tohoku University, Japan

MoP-ISCS-121

Fabrication of MoS₂ thin films on oxide-dielectric-covered substrates

Joonam Kim¹ and Eisuke Tokumitsu^{1,2}

¹School of Materials Science, Japan Advanced Institute of Science and Technology, Japan, ²Green Devices Research Center, Japan Advanced Institute of Science and Technology, Japan

MoP-ISCS-122

Crystal MoS₂ grown on Si substrates by sulfuring Mo thin films

Tsung-Shine Ko, Ding-Jie Liao, Nai-Wen Chang, and Der-Yuh Lin

Department of Electronic Engineering, National Changhua University of Education, Taiwan

MoP-ISCS-123

Morphology and photoluminescence of nanoscale few-layered MoS₂ prepared by liquid phase exfoliation

Da-Ren Hang, Krishna Hari Sharma, De-You Sun, Fong-Yao Su, and Sk Emdadul Islam

Department of Materials and Optoelectronic Science, National Sun Yat-sen University, Taiwan

MoP-ISCS-124

Optical and transport properties of Ni-doped MoS₂

Tsung-Shine Ko, Shi-Ming Jian, Cheng-Ching Huang, and Der-Yuh Lin

Department of Electronic Engineering, National Changhua University of Education, Taiwan

MoP-ISCS-125

Geometric and Electronic Structures of GaN Sheet

Yanlin Gao and Susumu Okada

University of Tsukuba, Japan

MoP-ISCS-126

Deposition properties of small molecular organic thin films by multi-jet mode electro-spray deposition

Ryo Terada,¹ Yoshiki Niinuma,¹ Yusuke Takatsuka,¹ Hiroyuki Ueda,¹ and Akihiko Kikuchi^{1,2}

¹Sophia University, Japan, ²Sophia Nanotechnology Research Center, Japan

MoP-ISCS-127

Fabrication of Alq₃/NPB small-molecule laminated structures with suppressed interface mixing by multi-jet mode electro-spray deposition

Hiroyuki Ueda,¹ Yusuke Takatsuka,¹ Yoshiki Niinuma,¹ Ryo Terada,¹ and Akihiko Kikuchi^{1,2}

¹Sophia Univ, Japan, ²Sophia Nanotech Research Center, Japan

MoP-ISCS-128

Organic Photovoltaic Cell Fabricated by Electrospray Deposition Using Non-Halogenated Solvent

Kazuya Takahira, Asuki Toda, Katsumi Suzuki, Takeshi Fukuda, Norihiko Kamata, and Zentaro Honda

Saitama University, Japan

MoP-ISCS-129

Semi-transparent OLEDs Fabrication using Lamination Process

Yuuki Nishioka, Shigeki Naka, and Hiroyuki Okada

University of Toyama, Japan

MoP-ISCS-130

Structural and thermoelectric properties of TTF-I_{0.71} organic compound

Kei Hayashi, Kento Kuba, and Yuzuru Miyazaki

Department of Applied Physics, Graduate School of Engineering, Tohoku University, Japan

MoP-ISCS-131

Gate-bias and Temperature Dependence in Pentacene-based Organic Thin Film Transistor with MoO₃/Au ContactsSafizan Shaari,^{1,2} Shigeki Naka,¹ and Hiroyuki Okada¹*¹Graduate School of Science and Engineering, University of Toyama, Japan, ²School of Microelectronic Engineering, Universiti Malaysia Perlis, Malaysia*

MoP-ISCS-132

Pentacene Memory Transistors Using Monolayer of Ligand-removed Semiconductor Colloidal Nano-dots as a Floating Gate

Fumihoru Nakano, Kazuyuki Uno, and Ichiro Tanaka

Wakayama University, Japan

MoP-ISCS-133

Nonvolatile organic transistor-memory devices based on pentacene semiconductors and poly (methyl methacrylate)/graphene quantum-dot composite trap layersYing-Jun Shen,¹ Yan-Kuin Su,^{1,2} Hsin-Chieh Yu,¹ and Tsung-Hsien Kao¹*¹Institute of Microelectronics and Department of Electrical Engineering, Advanced Optoelectronic Technology Center, Center for Micro/Nano Science and Technology, National Cheng Kung University, Taiwan, ²Department of Electrical Engineering, Kun Shan University, Taiwan*

MoP-IPRM-001

Material Conversion of GaAs Nanowires by Post Growth TreatmentKohei Nishioka,¹ Hidetoshi Suzuki,² Kentaro Sakai,² and Fumitaro Ishikawa¹*¹Graduate School of Science and Engineering, Ehime University, Japan, ²Faculty of Engineering, University of Miyazaki, Japan*

MoP-IPRM-002

Selective area growth of GaSb nano-templates on GaAs (001) using atomic hydrogen assisted molecular beam epitaxyLudovic Desplanque,¹ Maria Fahed,¹ David Troadec,¹ Pierre Ruterana,² and Xavier Wallart¹*¹IEMN, UMR 8520, CNRS and University of Lille, France, ²CIMAP, UMR 6252 CNRS-ENSICAEN-CEA-UCBN, France*

MoP-IPRM-003

High-efficiency cryogenic temperatures yellow quantum dot for light emitting diodes

Andrea Pescaglino, Agnieszka Gocalinska, Gediminas Juska, Stefano Moroni, and Emanuele Pelucchi

Tyndall National Institute, University College Cork, Ireland

MoP-IPRM-004

Growth of Type-II InP Quantum Dots in InGaP Matrix by Using Solid-Source Molecular Beam Epitaxy for Intermediate-Band solar cells

Takeyoshi Sugaya and Takeshi Tayagaki

National Institute of Advanced Industrial Science and Technology (AIST), Japan

MoP-IPRM-005

Fabrication of nanowire growth templates by forming pinholes in SiO_x on Si

Huan Zhao Ternehäll, Elham Fadaly, and Mahdad Sadeghi

Department of Microtechnology and Nanoscience, Chalmers University of Technology, Sweden

MoP-IPRM-006

Influence of temperature on Sn incorporation into GeSn alloy grown by molecular beam epitaxy

Hui Li, Chiao Chang, and Hung-Hsiang Cheng

Center for Condensed Matter Sciences and Graduate Institute of Electronics Engineering, National Taiwan University, Taiwan

MoP-IPRM-007

Modeling InGaAs MOVPE in v-grooves and pyramidal recesses

Stefano Moroni,¹ Valeria Dimastrodonato,¹ Tung-Hsun Chung,¹ Gediminas Juska,¹ Agnieszka Gocalinska,¹ Dimitri Vvedensky,² and Emanuele Pelucchi¹

¹Tyndall National Institute, University College Cork, Ireland, ²The Blackett Laboratory, Imperial College London, United Kingdom

MoP-IPRM-008

Shape evolution and emission property of InP nanostructures under hydrides influence

Enrica Mura, Agnieszka Gocalinska, Gediminas Juska, Stefano Moroni, Andrea Pescaglino, and Emanuele Pelucchi

Tyndall National Institute, "lee Maltings", University College Cork, Ireland

MoP-IPRM-009

MBE growth and characterization of strained GaAsBi/GaAs MQWs

Pallavi Patil, Fumitaro Ishikawa, and Satoshi Shimomura

Department of Nano-electronics, Ehime University, Japan

MoP-IPRM-010

Annealing effects on the electroluminescence of InGaAsN/GaAsSb Type-II Quantum Well Diodes Grown on InP Substrates

Yuichi Kawamura,^{1,2} Ikuya Shishido,¹ Sho Tanaka,¹ and Shuichi Kawamata^{1,2}

¹Graduate School of Engineering, Osaka Prefecture University, Japan, ²Research Organization for University-community Collaboration, Osaka Prefecture University, Japan

MoP-IPRM-011

Growth and characterisation of InAsP/AlGaInP QD laser structuresAndrey B Krysa,¹ John S Roberts,¹ Jan Devenson,¹ Richard Beanland,² Ivan Karomi,^{3,4} Samuel Shutts,³ and Peter M Smowton³¹University of Sheffield, United Kingdom, ²University of Warwick, United Kingdom, ³Cardiff University, United Kingdom, ⁴University of Mosul, Iraq

MoP-IPRM-012

Statistical Investigations on the Development of GaAs/GaAsBi Core-Multi Shell Nanowires

Kyohei Takada, Yuto Kubota, Yoshihiko Akamatsu, Pallavi Patil, Fumitaro Ishikawa, and Satoshi Shimomura

Graduate School of Science and Engineering, Ehime University, Japan

MoP-IPRM-013

Optimizing the concentration profile of Zn with ruthenium doped InP

Harunaka Yamaguchi, Eiji Nakai, Hiroyuki Kawahara, Takehiro Nishida, and Hitoshi Watanabe

Mitsubishi Electric Corporation, Japan

MoP-IPRM-014

Cryogenic DC and RF Characteristics of InP HEMTs with Various Drain-Side Recess LengthsAkira Endoh,^{1,2} Issei Watanabe,¹ Akifumi Kasamatsu,¹ Tsuyoshi Takahashi,² Shoichi Shiba,² Yasuhiro Nakasha,² Taisuke Iwai,² and Takashi Mimura^{1,2}¹National Institute of Info. & Com. Tech., Japan, ²Fujitsu Laboratories Ltd., Japan

MoP-IPRM-015

Low-frequency and radio-frequency C-V characterization of epitaxially grown InAs/high-k vertical nanowire MOS gate stacks

Jun Wu, Kristofer Jansson, Aein Shiri Banadi, Erik Lind, and Lars-Erik Wernersson

Lund University, Sweden

MoP-IPRM-016

InAs/Al_{0.4}Ga_{0.6}Sb side gated vertical TFET on GaAs substrate

Vinay Chinni, Mohammed Zaknoune, Xavier Wallart, and Ludovic Desplanque

Institut D'électronique de Microélectronique et de Nanotechnologie, Lille University of Science and Technology, France

MoP-IPRM-017

Comparative Study on Noise Characteristics of As and Sb-based HEMTs

Takuto Takahashi, Shota Hatsushiba, Sachie Fujikawa, and Hiroki Inomata Fujishiro

Department of Applied Electronics, Tokyo University of Science, Japan

MoP-IPRM-018

RTD-based Reconfigurable Logic Gates for Programmable Logic Array Applications

Donghyeok Bae, Jaehong Park, Maengkyu Kim, Yongsik Jeong, and Kyoungsoon Yang

School of Electrical Engineering, Korea Advanced Institute of Science and Technology, Republic of Korea

MoP-IPRM-019

Effects of Border Traps on Transfer Curve Hysteresis and Split-CV Mobility Measurement in InGaAs Quantum-Well MOSFETsPaolo Pavan,¹ Nicolò Zagni,¹ Francesco Maria Puglisi,¹ Alireza Alian,² Aaron Thean,² Nadine Collaert,³ and Giovanni Verzellesi³¹DIEF, University of Modena and Reggio Emilia, Italy, ²IMEC, Belgium, ³DISMI, University of Modena and Reggio Emilia, Italy

MoP-IPRM-020

A Physical Based Equivalent Circuit Modeling Approach for Ballasted InP DHBT Multi-finger devices at Millimeter-wave FrequenciesVirginio Midili,¹ Michele Squartecchia,¹ Tom Keinicke Johansen,¹ Virginie Nodjiadjim,² Muriel Riet,² Jean-Yves Dupuy,² and Agnieszka Konczykowska²¹Technical University of Denmark, Denmark, ²III-V Lab, France

MoP-IPRM-021

Cryogenic low-noise InP HEMTs: A source-drain distance studyEunjung Cha,¹ Arsalan Pourkabirian,¹ Joel Schlee,² Niklas Wadefalk,² Giuseppe Moschetti,² Piotr Starski,¹ Göran Alesig,¹ John Halonen,¹ Bengt Nilsson,¹ Per-åke Nilsson,¹ and Jan Grahn¹¹Department of Microtechnology and Nanoscience, Chalmers University of Technology, Sweden, ²Low Noise Factory AB, Mölndal, Sweden

MoP-IPRM-022

Long tail Zn diffusion in InGaAsP and InGaAlAs quaternary alloys

Takeshi Kitatani, Kaoru Okamoto, Kenji Uchida, and Shigehisa Tanaka

Oclaro Japan, Inc., Japan

MoP-IPRM-023

Bismuth for tailoring and modification of InP-based detector and laser structures in 2-3 μm band

Yi Gu, Yong-Gang Zhang, Xing-You Chen, Ying-Jie Ma, Su-Ping Xi, Ben Du, and Ai-Zhen Li

Shanghai Institute of Microsystem and Information Technology, Chinese Academy of Sciences, China

MoP-IPRM-024

Selective Area Grown AlGaInAs Multi-quantum Wells Characterization and Modeling for Photonic Integrated DevicesBinet Guillaume,^{1,2} Decobert Jean,¹ Nadine Lagay,¹ Alvaro Maia,² Pierre-Yves Lagrée,² and Fernando Rinaldi³¹III-V Lab, France, ²Institut Jean Le Rond d'Alembert, Sorbonne Universités, France, ³Bruker Axs GmbH, Germany

MoP-IPRM-025

InP-based Uni-Traveling-Carrier Photodiodes (UTC-PDs) with 3-dB Bandwidth Over 135 GHzQianqian Meng,¹ Hong Wang,^{1,2} Chongyang Liu,¹ Xin Guo,¹ and Kiansiong Ang¹¹Temasek Laboratories, Nanyang Technological University, Singapore, ²School of Electrical and Electronic Engineering, Nanyang Technological University, Singapore

MoP-IPRM-026

Monolithic Fabrication of InSb-based Photo-Pixel for Mid-IR Imaging

Chengzhi Xie, Vincenzo Pusino, Ata Khalid, Mohsin Aziz, Matthew Steer, and David Cumming

Electronics and Nanoscale Division in The School of Engineering at The University of Glasgow, United Kingdom

MoP-IPRM-027

A Low Dark Current Planar-type InGaAs Guard-ring PIN Photodiode Using an ALD- Al_2O_3 Passivation for Short-wave Infrared Imaging Applications

Youngjun Kim, Inseob Noh, Hyungjun Noh, Jeahong Park, and Kyounghoon Yang

School of Electrical Engineering, Korea Advanced Institute of Science and Technology, Republic of Korea

MoP-IPRM-028

Photonic Integrated Device of Highly-Stacked Quantum Dot using Quantum Dot Inter-mixing by Ion ImplantationShin'e Matsui,¹ Yuki Takei,¹ Atsushi Matsumoto,² Koichi Akahane,² Yuichi Matsushima,¹ Hiroshi Ishikawa,¹ and Katsuyuki Uta¹*¹Faculty of Science and Engineering, Waseda University, Japan, ²National Institute of Information and Communications Technology (NICT), Japan*

MoP-IPRM-029

Monitoring the Long-term Frequency Stability of InAs/InP Quantum-dash-based Mode Locked Lasers via Terminal VoltageKamel Merghem,¹ Vivek Panapakham,¹ Quentin Gaimard,¹ Francois Lelarge,² and Abderrahim Ramdane¹*¹CNRS LPN, France, ²III-V Lab, France*

MoP-IPRM-030

Two-state Lasing in GaAs-based InAs/InGaAs Quantum Dot Mode-locked LaserZhongliang Qiao,¹ Xiang Li,¹ Xin Guo,¹ Hong Wang,¹ Rui Wang,² Kian Siong Ang,³ and Chongyang Liu³*¹NOVITAS, Nanoelectronics Centre of Excellence, School of Electrical and Electronic Engineering, Nanyang Technological University, Singapore, ²Brucker Singapore Pte. Ltd., Singapore, ³Temasek Laboratories, Nanyang Technological University, Singapore*

MoP-IPRM-031

Evidence of Quantum Confined Stark Effect Due to Doping Profile in InAsP/InP Quantum Well Structures and its Modification by Ion BombardmentJean-Pierre Landesman,¹ Juan Jiménez,² Christophe Levallois,³ Frédéric Pommereau,⁴ Alexandre Beck,³ and Alfredo Torres²*¹University of Rennes 1 and CNRS, France, ²University of Valladolid, Spain, ³INSA Rennes and CNRS, France, ⁴III-V Lab, France*

MoP-IPRM-033

Thermal Management of Monolithic and Heterogeneous Integrated LasersIda Lucci,¹ Mounib Bahri,² Yoan Léger,¹ and Charles Cornet¹*¹UMR Foton, CNRS, INSA Rennes, Université de Rennes 1, France, ²Laboratoire de Photonique et Nanostructures, CNRS UPR 20, France*

MoP-IPRM-034

Optimization of Semiconductor Ridge Waveguide Lasers for Improved Temperature CharacteristicsXiang Li,¹ Hong Wang,¹ Zhongliang Qiao,¹ Xin Guo,¹ Kian Siong Ang,² and Chongyang Liu²¹Novitas, Nanoelectronics Centre of Excellence, School of Electrical and Electronic Engineering, Nanyang Technological University, Singapore, ²Temasek Laboratories, Nanyang Technological University, Singapore

MoP-IPRM-035

Fabrication of nitride LEDs using chemical lift-off from a GaN/sapphire templateRay-Hua Horng,¹ Hsu-Hung Hsueh,² Sin-Liang Ou,³ and Dong-Sing Wu⁴¹ Department of Electronics Engineering, National Chiao Tung University, Taiwan, ²Graduate Institute of Precision Engineering, National Chung Hsing University, Taiwan, ³Department of Materials Science and Engineering, Da Yeh University, Taiwan, ⁴Department of Materials Science and Engineering, National Chung Hsing University, Taiwan

MoP-IPRM-036

The electrical properties of HgCdTe layers grown by MBE on Si and P + / n junction formed on its basisMaxim Yakushev,¹ Alexandr Guzev,² Anatoliy Kovchavtcev,² Alexey Tsarenko,² Vasiliy Varavin,¹ Vladimir Vasilyev,³ Sergei Dvoretzky,¹ Denis Marin,¹ Irina Sabinina,³ Dmitriy Shefer,¹ Georgiy Sidorov,³ and Yuriy Sidorov¹¹Laboratory of Epitaxial Technology from Molecular Beams of A2B6 Compounds, Institute of Semiconductor Physics, Russia, ²Laboratory of Physical Principles for Integrated Microelectronics, Institute of Semiconductor Physics, Russia, ³Laboratory for Physical-technological Principles of Making A2B6-based Devices, Institute of Semiconductor Physics, Russia

June 28th (Tuesday)

TuB1 High-voltage Devices

Room B (201) 8:30-10:30

Chair: K. J. Chen and T. Tanaka

TuB1-1 (Invited)

8:30 - 9:00

Epitaxial growth of GaN-based heterostructures of high quality on Si substrates using a large lattice-mismatch induced stress control technology

Jianpeng Chen, Xuelin Yang, Maojun Wang, and Bo Shen

State Key Laboratory of Artificial Microstructure and Mesoscopic Physics, School of Physics, Peking University, China

TuB1-2 (Invited)

9:00 - 9:30

Measurement of Channel Temperature in Ga₂O₃ MOSFETsMan Hoi Wong,¹ Yoji Morikawa,² Kohei Sasaki,^{3,1} Akito Kuramata,³ Shigenobu Yamakoshi,³ and Masataka Higashiwaki¹¹National Institute of Information and Communications Technology, Japan, ²Silvaco Japan Co., Ltd., Japan, ³Tamura Corporation, Japan

TuB1-3 9:30 - 9:45
High Voltage Low Current Collapse AlGaN/GaN MISHEMTs with in-situ SiN Gate Dielectric

Huaxing Jiang,¹ Chao Liu,¹ Xing Lu,² and Kei May Lau¹

¹Department of Electronic and Computer Engineering, Hong Kong University of Science and Technology, Hong Kong, ²State Key Laboratory of Electrical Insulation and Power Equipment, School of Electrical Engineering, Xi'an Jiaotong University, China

TuB1-4 9:45 - 10:00
Optimization of the source field-plate design for low dynamic R_{DS-ON} dispersion of Al-GaN/GaN MIS-HEMTs

Nicolo Ronchi,¹ Benoit Bakeroot,² Shuzhen You,¹ Jie Hu,¹ Steve Stoffels,¹ and Stefaan Decoutere¹

¹IMEC, Belgium, ²CMST, IMEC & Ghent University, Belgium

TuB1-5 10:00 - 10:15
Impact of Drain Electrode Shape Irregularities on Breakdown Voltage of AlGaN/GaN HEMTs

Shintaro Ohi, Shinya Makino, Taisei Yamazaki, Hirokuni Tokuda, Joel Tacla Asubar, and Masaaki Kuzuhara

Graduate School of Engineering, University of Fukui, Japan

TuB1-6 10:15 - 10:30
Critical Heterostructure Design for Low On-Resistance Normally-Off Double-Channel MOS-HEMT

Jin Wei, Shenghou Liu, Baikui Li, Xi Tang, Gaofei Tang, Zhaofu Zhang, and Kevin J. Chen

Department of Electronic and Computer Engineering, The Hong Kong University of Science and Technology, Hong Kong

TuC1 Nanostructures

Room C (202) 8:30-10:30

Chair: K. Volz and T. Nakaoka

TuC1-1 (Invited) 8:30 - 9:00
Electronic properties of chalcogenide semiconductor nanostructures and thin-films

Oded Millo

Racah Institute of Physics, The Hebrew University of Jerusalem, Israel

TuC1-2 9:00 - 9:15
Nanoscale heat transport in single-crystalline Si and amorphous SiGe phononic crystals

Junki Nakagawa,¹ Jeremie Maire,¹ Kentaro Sawano,² and Masahiro Nomura^{1,3,4}

¹Institute of Industrial Science, The University of Tokyo, Japan, ²Advanced Research Laboratories, Tokyo City University, Japan, ³Institute for Nano Quantum Information Electronics, The University of Tokyo, Japan, ⁴JST, PRESTO, Japan

TuC1-3 9:15 - 9:30
Terahertz spectroscopy of single Ce-doped C₈₂ molecules using sub-nm-scale gap electrodes

Shaoqing Du,¹ Kenji Yoshida,¹ Ya Zhang,¹ and Kazuhiko Hirakawa^{1,2}

¹Center for Photonics Electronics Convergence, Institute of Industrial Science, University of Tokyo, Japan, ²Institute for Nano Quantum Information Electronics, University of Tokyo, Japan

TuC1-4 9:30 - 9:45
1-D Electronic Density of States for InAs/InP Quantum Dashes probed by Scanning Tunneling Spectroscopy

Jean-Christophe Girard,¹ Konstantinos Papatryfonos,¹ Guillemín Rodary,¹ Christophe David,¹ François Lelarge,² and Abderrahim Ramdane¹

¹Cnrs Laboratory for Photonics and Nanostructures, France, ²III-V Lab, a Joint Lab of 'Alcatel Lucent Bell Labs', 'Thales Research and Technology', and 'CEA Leti', France

TuC1-5 9:45 - 10:00
Hybrid InAs/GaAs and GaSb/GaAs Quantum Dot Structure

Hai-Ming Ji,¹ Baolai Liang,² Paul J. Simmonds,² Bor-Chau Juang,³ Tao Yang,¹ and Diana L. Huffaker^{2,3}

¹Institute of Semiconductors, Chinese Academy of Sciences, China, ²California Nanosystems Institute, University of California Los Angeles, Los Angeles, United States of America, ³Department of Electrical Engineering, University of California Los Angeles, United States of America

TuC1-6 10:00 - 10:15
Nanostructures and surface reconstructions in Mn / III-V systems and MnSb

Haiyuan Wang, Collins Ouserigha, Christopher Burrows, and Gavin Bell

Department of Physics, University of Warwick, Coventry, United Kingdom, United Kingdom

TuC1-7 10:15 - 10:30
Photonic crystal membrane with single crystalline rare-earth oxide using selective area growth by MBE

Takehiko Tawara,^{1,2} Hiroo Omi,^{1,2} Thomas McManus,¹ Aleix Llenas,¹ Eiichi Kuramochi,^{1,2} Satoru Adachi,³ and Hideki Gotoh¹

¹NTT Basic Research Laboratories, Japan, ²NTT Nanophotonics Center, Japan, ³Hokkaido University, Japan

TuD1 Organic Semiconductor & Flexible Materials

Room D (203) 8:30-10:30

Chair: H. Okada and T. Mori

TuD1-1 (Invited) 8:30 - 9:00

Scaling of Organic Thin-Film Transistors and circuits

Dietmar Knipp

Jacobs University Bremen, Germany

TuD1-2 (Invited) 9:00 - 9:30

Challenges for ultra-thin and highly flexible OLEDs fabricated by roll to roll process

Takashi Minakata,^{1,2} Mitsuru Tanamura,¹ Yasuhiro Mitamura,¹ Masayuki Imashiro,¹ Akira Horiguchi,¹ Akira Sugimoto,¹ Masahiko Yamashita,^{1,2} Yukito Yada,¹ Nobuki Ibaraki,¹ and Hiroshi Tomiyasu¹

¹Cereba, Japan, ²Asahikasei, Japan

TuD1-3 (Invited) 9:30 - 10:00

Efficient and Stable Large-area Perovskite Solar Cells

Liyuan Han

National Institute for Materials Science, Japan

TuD1-4 10:00 - 10:15

Effect of Alkyl Chain Length of Fluorinated Self-Assemble Monolayer to Organic Light-Emitting Diodes as a Hole Injection Layer

Tatsuo Mori,¹ Tomoya Inden,² and Takao Nishikawa³

¹Department of Electrical Engineering, Aichi Institute of Technology, Japan, ²Department of Electrical Engineering and Computer Science, Graduate School of Engineering, Nagoya University, Japan, ³Center for Regional Collaboration in Research and Education, Iwate University, Japan

TuD1-5 10:15 - 10:30

Vertically Graded Organic Photovoltaic Cells Using Alternative Intermittent Electro-spray Co-deposition

Takeshi Fukuda and Katsumi Suzuki

Saitama University, Japan

Coffee Break

10:30 - 11:00

TuB2 GaN: Growth & Characterization

Room B (201) 11:00-12:30

Chair: K.Matsumoto and Y.Otoki

TuB2-1 (Invited) 11:00 - 11:30

Spatio-time-resolved cathodoluminescence study on high AlN mole fraction $\text{Al}_x\text{Ga}_{1-x}\text{N}$ structures grown by metalorganic vapor phase epitaxy

Shigefusa F Chichibu,¹ Youichi Ishikawa,¹ Kentaro Furusawa,¹ Akira Uedono,² Hideto Miyake,³ and Kazumasa Hiramatsu³

¹IMRAM, Tohoku University, Japan, ²University of Tsukuba, Japan, ³Mie University, Japan

TuB2-2 11:30 - 11:45

Structural and Electrical Transport Properties of Si Doped GaN Nanowires

Zhihua Fang,^{1,2,3} Eric Robin,⁴ Elena Rozas-Jiménez,⁵ Ana Cros,⁵ Fabrice Donatini,^{1,3} Nicolas Mollard,⁴ Julien Pernot,^{1,3,6} and Bruno Daudin^{1,2}

¹Univ. Grenoble Alpes, France, ²Cea, Inac-sp2m, "nanophysique et Semiconducteurs" Group, France, ³Cnrs, Inst. Neel, France, ⁴Cea, Inac, Minatec Campus, France, ⁵Materials Science Institute, University of Valencia, Spain, ⁶Institut Universitaire de France, France

TuB2-3 11:45 - 12:00
Flow-rate Modulation Epitaxy of Nonpolar m-plane AlN Homoepitaxial Layers Grown on AlN Bulk Substrates
 Junichi Nishinaka, Yoshitaka Taniyasu, Tetsuya Akasaka, and Kazuhide Kumakura
NTT Basic Research Laboratories, NTT corporation, Japan

TuB2-4 12:00 - 12:15
Fabrication of an a-plane AlGaN Quantum well on r-plane sapphire
 Masafumi Jo and Hideki Hirayama
Riken, Japan

TuB2-5 12:15 - 12:30
Curvature of HVPE c-Plane Grown GaN Wafers in the Relation to Stress Gradients Caused by Inclined Threading Dislocations
 Humberto Miguel Foronda,¹ Alexey E Romanov,^{1,2,3} Erin C Young,¹ Christian A Robertson,¹ Glenn E Beltz,⁴ and James S Speck¹
¹Materials Department, UC Santa Barbara, United States of America, ²Ioffe Physico-Technical Institute RAS, Russia, ³ITMO University, Russia, ⁴Mechanical Engineering Department, UC Santa Barbara, United States of America

TuC2 Oxide Electronics

Room C (202) 11:00-12:30

Chair: T. Omata

TuC2-1 (Invited) 11:00 - 11:30
Properties and functionalities of organic-oxide heterointerfaces
 Masaki Nakano
QPEC and Department of Applied Physics, The University of Tokyo, Japan

TuC2-2 11:30 - 11:45
Vertical Schottky Barrier Diodes Fabricated on Un-intentionally Doped and Sn-doped (-201) bulk β -Ga₂O₃ Substrates
 Amit Verma¹ and Debdeep Jena^{1,2}
¹School of Electrical and Computer Engineering, Cornell University, United States of America, ²Department of Materials Science and Engineering, Cornell University, United States of America

TuC2-3 11:45 - 12:00
Fabrication of α -Ga₂O₃ using α -(Al_xGa_{1-x})₂O₃ Buffer Layers and its Crystal Structure Properties
 Riena Jinno,¹ Takayuki Uchida,¹ Kentaro Kaneko,² and Shizuo Fujita²
¹Department of Electronic Science and Engineering, Kyoto University, Japan, ²Photonics and Electronics Science and Engineering Center, Kyoto University, Japan

TuC2-4 12:00 - 12:15
Scalability of Zinc Oxide Thin-Film Transistors for RF Amplifiers and DC Switch Applications
 Gregg Huascar Jessen,¹ Michael Schuette,¹ Kevin Leedy,¹ Antonio Crespo,¹ Thomas Donigan,¹ Andrew Green,² Dennis Walker, Jr.,¹ Stephen Tetlak,¹ and Karynn Sutherland¹
¹Air Force Research Laboratory, United States of America, ²Wyle, United States of America

TuG2-5 12:15 - 12:30
Mapping of Au/a-IGZO Schottky Contacts by Using Scanning Internal Photoemission Microscopy

Kenji Shiojima and Masato Shingo

Graduate School of Electrical and Electronics Engineering, University of Fukui, Japan

TuD2 Nano Materials Growth

Room D (203) 11:00-12:30

Chair: H.Udono and S. Wang

TuD2-1 (Invited) **Cancelled** 11:00 - 11:30
Patterned III-V Nanopillars: A platform for integrated optoelectronic devices

Diana Huffaker

Cardiff University, United Kingdom

TuD2-2 11:30 - 11:45
Increasing the emission wavelength of InAs quantum dot grown on InP substrates using a dot in well structure

Kouichi Akahane,¹ Atsushi Matsumoto,¹ Toshimasa Umezawa,¹ Naokatsu Yamamoto,¹ Keita Hashimoto,² and Hiroshi Takai²

¹National Institute of Information and Communications Technology, Japan, ²Tokyo Denki University, Japan

TuD2-3 11:45 - 12:00
Self-Catalyzed Growth of Highly Vertical GaAs Core-Shell Nanowires on Chemically-Treated Si(111) Surfaces

Siew Li Tan,^{1,2} Yann Genuist,^{1,3} Henri Mariette,^{2,3} and Nikos T. Pelekanos^{1,2,4}

¹INAC, CEA Grenoble, France, ²Univ. Grenoble Alpes, France, ³Institut NEEL, CNRS, France, ⁴Materials Science & Technology Dept., Univ. of Crete and IESL/FORTH, Greece

TuD2-4 12:00 - 12:15
Study of Re, Au, and Fe Dopant Effect on the Structure and Optical Properties of Molybdenum Disulfide Single Crystals

Sigiro Mula^{1,2} and Ho Ching-Hwa³

¹Department of Physics Education, Faculty of Teacher Training and Education, University of HKBP Nommensen, Indonesia, ²Department of Electronic and Computer Engineering, National Taiwan University of Science and Technology, Taiwan, ³Graduate Institute of Applied Science and Technology, National Taiwan University of Science and Technology, Taiwan

TuD2-5 12:15 - 12:30
p-BaSi₂/n-Si heterojunction solar cells with 9.0 % efficiency

Suguru Yachi, Ryota Takabe, Daichi Tsukahara, Hiroki Takeuchi, Kaoru Toko, and Takashi Suemasu

University of Tsukuba, Japan

Lunch Break

12:30 - 14:00

| TuB3 | Nanostructured Photonic Devices | Room B (201) | 14:00-16:00 |
|---|---|--------------|---------------|
| <i>Chair: J. P. Reithmaier and T. Asano</i> | | | |
| TuB3-1 (Invited) | | | 14:00 - 14:30 |
| | Current Trends in High-Efficiency III-V Nanostructured Solar Cells | | |
| | Yoshitaka Okada | | |
| | <i>RCAST, University of Tokyo, Japan</i> | | |
| TuB3-2 | | | 14:30 - 14:45 |
| | Two-wavelength Switchable Narrowband Thermal Emitters | | |
| | Takuya Inoue, Anqi Ji, Menaka De Zoysa, Takashi Asano, and Susumu Noda | | |
| | <i>Department of Electronic Science and Engineering, Kyoto University, Japan</i> | | |
| TuB3-3 | | | 14:45 - 15:00 |
| | Demonstration of a Plasmonic Laser using Quantum Dot Gain Medium | | |
| | Jinfa Ho, ¹ Jun Tatebayashi, ¹ Sylvain Sergent, ¹ Chee Fai Fong, ² Yasutomo Ota, ¹ Satoshi Iwamoto, ^{1,2} and Yasuhiko Arakawa ^{1,2} | | |
| | <i>¹Institute for Nano Quantum Information Electronics, University of Tokyo, Japan, ²Institute of Industrial Science, University of Tokyo, Japan</i> | | |
| TuB3-4 | | | 15:00 - 15:15 |
| | InP on SOI Electrically Driven Photonic Crystal Nanolasers | | |
| | Guillaume Crosnier, ^{1,2} Dorian Sanchez, ² Paul Monnier, ² Sophie Bouchoule, ² Gregoire Beaudoin, ² Isabelle Sagnes, ² Rama Raj, ² and Fabrice Raineri ^{2,3} | | |
| | <i>¹Stmicroelectronics, France, ²CNRS-IPN, France, ³Université Paris Diderot, France</i> | | |
| TuB3-5 | | | 15:15 - 15:30 |
| | Highly pure and stable single photon source directly coupled to a fiber | | |
| | Satoru Odashima, ¹ Hirotaka Sasakura, ² Hideaki Nakajima, ³ and Hidekazu Kumano ³ | | |
| | <i>¹Department of Mechanical Engineering, Hachinohe Institute of Technology, Japan, ²Creative Research Institution, Hokkaido University, Japan, ³Research Institute for Electronic Science, Hokkaido University, Japan</i> | | |
| TuB3-6 | | | 15:30 - 15:45 |
| | Fabrication of photonic-crystal structures by TBAs-based MOVPE for photonic-crystal lasers | | |
| | Masahiro Yoshida, Menaka De Zoysa, Kenji Ishizaki, Ranko Hatsuda, Yoshinori Tanaka, Hitoshi Kitagawa, and Susumu Noda | | |
| | <i>Department of Electronic Science and Engineering Kyoto University, Japan</i> | | |
| TuB3-7 | | | 15:45 - 16:00 |
| | Refractive index control by quantum well intermixing for light confinement in VCSEL | | |
| | Minoru Saito, Shouhei Moriwaki, and Tomoyuki Miyamoto | | |
| | <i>Photonic Integration System Research Center, P&I Lab., Tokyo Institute of Technology, Japan</i> | | |

TuC3 Spin-related Physics

Room C (202) 14:00-16:00

Chair: N.Aoki

TuC3-1 (Invited) 14:00 - 14:30

Spintronics with semiconductor nanowiresThomas Schäpers,¹ Sebastian Heedt,¹ Andreas Bringer,² Isabel Otto,¹ Kamil Sladek,¹ Hilde Hardtdegen,¹ Detlev Grützmacher,¹ and Werner Prost³¹Peter Grünberg Institut 9, Forschungszentrum Jülich, 52425 Jülich, Germany, ²Peter Grünberg Institut 1, Forschungszentrum Jülich, 52425 Jülich, Germany, ³State Electronics Department, University of Duisburg-essen, 47057 Duisburg, Germany

TuC3-2 14:30 - 14:45

Vertical spin electric-double-layer transistorHiroshi Terada,¹ Le Duc Anh,¹ Shinobu Ohya,¹ Yoshihiro Iwasa,² and Masaaki Tanaka¹¹Department of Electrical Engineering and Information Systems, The University of Tokyo, Japan, ²Department of Applied Physics, The University of Tokyo, Japan

TuC3-3 14:45 - 15:00

Determination of the bulk Dresselhaus spin-orbit interaction parameter in an InGaAs quantum well

Kohei Yoshizumi, Makoto Kohda, and Junsaku Nitta

Department of Materials Science, Tohoku University, Japan

TuC3-4 15:00 - 15:15

Spin coherence enhanced by in-plane electric field-induced spin-orbit interactionYoji Kunihashi,¹ Haruki Sanada,¹ Hideki Gotoh,¹ Koji Onomitsu,¹ Makoto Kohda,² Nitta Junsaku,² and Tetsuomi Sogawa¹¹NTT Basic Research Laboratories, NTT Corporation, Japan, ²Department of Materials Science, Tohoku University, Japan

TuC3-5 15:15 - 15:30

Hole g-Factor Anisotropies in Individual InAs Quantum RingsReina Kaji,¹ Takahiro Tominaga,¹ Yu-Nien Wu,² Ming-Fan Wu,² Shun-Jen Cheng,² and Satoru Adachi¹¹Department of Applied Physics, Hokkaido University, Japan, ²Department of Electrophysics, National Chiao Tung University, Taiwan

TuC3-6 15:30 - 15:45

Auger Recombination in InAs: Role of Spin-Orbit Coupling and PhononsJimmy-Xuan Shen,¹ Daniel Steiauf,² Emmanouil Kioupakis,³ and Chris G. van de Walle²¹Department of Physics, University of California Santa Barbara, United States of America, ²Materials Department, University of California Santa Barbara, United States of America, ³Department of Material Science, University of Michigan, United States of America

TuC3-7 15:45 - 16:00

Simulating the Ising Hamiltonian with phonons

Imran Mahboob, Hajime Okamoto, and Hiroshi Yamaguchi

NTT Basic Research Labs., Japan

TuD3 Epitaxy & Novel Materials

Room D (203) 14:00-16:00

Chair: K. E. Moselund

TuD3-1 (Invited) 14:00 - 14:15

Heteroepitaxy of InP on Si for photonic and photovoltaic applications

Sebastian Lourduoss

Department of Materials and Nano Physics, Royal Institute of Technology, Sweden

TuD3-2 14:30 - 14:45

Growth of InGaAsP-based MQW Layer on InP Template Bonded to Si Substrate for Fabricating Membrane LasersTakuro Fujii,^{1,2} Koji Takeda,^{1,2} Erina Kanno,¹ Hidetaka Nishi,^{1,2} Koichi Hasebe,^{1,2} Takaaki Kakitsuka,^{1,2} Tsuyoshi Yamamoto,¹ and Shinji Matsuo^{1,2}*¹NTT Device Technology Labs., Japan, ²NTT Nanophotonics Center, Japan*

TuD3-3 14:45 - 15:00

Enhancing Light Extraction from III-Nitride Devices Using Moth-Eye Nanostructures Formed by Colloidal LithographyChristopher D. Pynn,¹ Federico L. Gonzalez,² Lesley Chan,² Alexander Berry,² Sang Ho Oh,³ Tal Margalith,¹ Daniel E. Morse,⁴ Shuji Nakamura,^{1,3} Michael J. Gordon,² and Steven P. DenBaars^{1,3}*¹Materials Department, University of California, Santa Barbara, United States of America, ²Department of Chemical Engineering, University of California, Santa Barbara, United States of America, ³Department of Electrical and Computer Engineering, University of California, Santa Barbara, United States of America, ⁴Department of Molecular, Cellular, and Developmental Biology, University of California, Santa Barbara, United States of America*

TuD3-4 15:00 - 15:15

Anomalous Ga incorporation into InGaAs microdiscs selectively grown on Si (111)

Tohma Watanabe, Masakazu Sugiyama, and Yoshiaki Nakano

Department of Electronic Engineering, School of Engineering, The University of Tokyo, Japan

TuD3-5 15:15 - 15:30

Suppressing Ge Diffusion by GaAsSb for Molecular Beam Epitaxy of InGaAs on GeWei-Jen Hsueh,¹ Pei-Chin Chiu,¹ Ming-Hwei Hong,² and Jen-Inn Chyi^{1,3}*¹Department of Electrical Engineering, National Central University, Taiwan, ²Department of Physics, National Taiwan University, Taiwan, ³Research Center for Applied Sciences, Taiwan*

TuD3-6 15:30 - 15:45

MBE-grown $\text{Mg}_{0.13}\text{Cd}_{0.87}\text{Te}$ for MgCdTe (1.7 eV)/ Si (1.1 eV) tandem solar cell applicationsCalli Campbell,^{1,2} Ernesto Suarez,^{1,3} Yuan Zhao,^{1,3} Xin-Hao Zhao,^{1,2} Jacob Becker,^{1,3} and Yong-Hang Zhang^{1,3}*¹Center for Photonics Innovation, Arizona State University, United States of America, ²School for Engineering of Matter, Transport and Energy, Arizona State University, United States of America, ³School of Electrical, Computer and Energy Engineering, Arizona State University, United States of America*

TuD3-7 15:45 - 16:00
Epitaxial Lateral Overgrowth of Ga_xIn_{1-x}P Towards Coherent Ga_xIn_{1-x}P/Si Heterojunction by Hydride Vapor Phase Epitaxy

Giriprasanth Omanakuttan, Stamoulis Stergiakis, Abhishek Sahgal, Ilya Sychugov, Sebastian Lourdudoss, and Yan-Ting Sun

Department of Materials and Nano Physics, School of Information and Communication Technology, KTH Royal Institute of Technology, Sweden

Coffee Break

16:00 - 16:30

TuB4 Novel Optical Devices & Applications

Room B (201) 16:30-18:30

Chair: H. Yagi

TuB4-1 (Invited) 16:30 - 17:00
Photonic Crystal Nanolasers and Its Application to Bio-Sensing
 Toshihiko Baba

Yokohama National University, Japan

TuB4-2 17:00 - 17:15
InGaAs/AlGaAsSb APD with over 200 GHz gain-bandwidth product
 Xinxin Zhou, Shiyu Xie, Shiyong Zhang, Jo Shien Ng, and Chee Hing Tan

Department of Electronic and Electrical Engineering, University of Sheffield, United Kingdom

TuB4-3 17:15 - 17:30
Temperature dependence of avalanche gain in Al_{0.85}Ga_{0.15}As_{0.56}Sb_{0.44} APD
 Shiyu Xie, Xinxin Zhou, Shiyong Zhang, Jo Shien Ng, and Chee Hing Tan

Department of Electronic and Electrical Engineering, University of Sheffield, United Kingdom

TuB4-4 17:30 - 17:45
Guided mode resonant photodiode for highly sensitive infrared imaging

Michaël Verdun,^{1,2} Benjamin Portier,¹ Katarzyna Jaworowicz,¹ Julien Jaeck,² François Lelarge,³ Stéphane Guilet,¹ Christophe Dupuis,¹ Riad Haïdar,^{2,4} Fabrice Pardo,¹ and Jean-Luc Pelouard¹

¹MiNaO - LPN-CNRS, France, ²MiNaO - ONERA The French Aerospace Lab, France, ³III-V Lab, France, ⁴Ecole Polytechnique, France

TuB4-5 17:45 - 18:00
Structural and electrical properties of InAs/GaSb superlattices grown by metalorganic vapor phase epitaxy for midwavelength infrared detectors

Suguru Arikata,¹ Takashi Kyono,¹ Kouhei Miura,² Sundararajan Balasekaran,² Hiroshi Inada,² Yasuhiro Iguchi,² Michito Sakai,³ Haruyoshi Katayama,³ Masafumi Kimata,⁴ and Katsushi Akita¹

¹Semiconductor Technologies Laboratory, Sumitomo Electric Industries, Ltd., Japan, ²Transmission Devices Laboratory, Sumitomo Electric Industries, Ltd., Japan, ³Sensor System Research Group, Japan Aerospace Exploration Agency (JAXA), Japan, ⁴College of Science and Engineering, Ritsumeikan Univ., Japan

TuB4-6 18:00 - 18:15
Homojunction GaAs diode with periodically-inverted structure for nonlinear optical devices

Ryosuke Suzuki,¹ Tomonori Matsushita,^{1,2} and Takashi Kondo^{1,2}

¹Department of Materials Engineering, School of Engineering, University of Tokyo, Japan, ²Research Center for Advanced Science and Technology, University of Tokyo, Japan

TuB4-7 18:15 - 18:30
Array of Entangled-light-emitting Diodes with Site-controlled Pyramidal Quantum Dots

Tung-Hsun Chung, Gediminas Juska, Stefano T. Moroni, Agnieszka Gocalinska, Andrea Pescaglini, and Emanuele Pelucchi

Tyndall National Institute, University College Cork, Ireland

TuC4 2D Materials

Room C (202) 16:30-18:30

Chair: K.Matsumoto

TuC4-1 (Invited) 16:30 - 17:00
Quantum Transport in van der Waals Junctions of Graphene and 2D Materials

Tomoki Machida

Institute of Industrial Science, University of Tokyo, Japan

TuC4-2 17:00 - 17:15
Vertical Transport in Graphene/Transition Metal Dichalcogenide van der Waals Heterostructure

Rai Moriya,¹ Yohta Sata,¹ Takehiro Yamaguchi,¹ Yoshihisa Inoue,¹ Sei Morikawa,¹ Satoru Masubuchi,¹ and Tomoki Machida^{1,2}

¹Institute of Industrial Science, University of Tokyo, Japan, ²Institute for Nano Quantum Information Electronics, University of Tokyo, Japan

TuC4-3 17:15 - 17:30
Imaging local transport property within MoS₂ transistors by scanning gate microscopy

Masahiro Matsunaga,¹ Ayaka Higuchi,¹ Guanchen He,² Jonathan P Bird,² Yuichi Ochiai,¹ and Nobuyuki Aoki^{1,3}

¹Graduate School of Advanced Integration Science, Chiba University, Japan, ²Department of Electrical Engineering, University at Buffalo, SUNY, United States of America, ³JST-PRESTO, Japan

TuC4-4 17:30 - 17:45
Electronic Properties of MoS₂ Nanoribbon with Strain Using Tight Binding Method

Shuo-Fan Chen and Yuh-Renn Wu

Graduate Institute of Photonics and Optoelectronics, National Taiwan University, Taiwan

TuC4-5 17:45 - 18:00
Photoluminescence Quantum Yield and Long Exciton Radiative Lifetime in Monolayer Two-Dimensional Transition Metal Dichalcogenides

N. Baizura Mohamed,^{1,2} Feijiu Wang,¹ Sandhaya Koirala,¹ Hong En Lim,¹ Shinichiro Mouri,¹ Yuhei Miyauchi,¹ and Kazunari Matsuda¹

¹Institute of Advanced Energy, Kyoto University, Kyoto, Japan, ²Universiti Teknologi Mara Malaysia, Selangor, Malaysia

TuC4-6 18:00 - 18:15

Synthesis of 2D materials on epitaxial catalyst films by chemical vapor deposition

Daiyu Kondo,^{1,2} Kenjiro Hayashi,^{1,2} Masako Kataoka,¹ Taisuke Iwai,¹ and Shintaro Sato^{1,2}

¹Fujitsu Laboratories Ltd., Japan, ²Fujitsu Limited, Japan

TuC4-7 18:15 - 18:30

Dielectric breakdown of layered insulator

Kosuke Nagashio,^{1,2} Yoshiaki Hattori,¹ Takashi Taniguchi,³ and Kenji Watanabe³

¹University of Tokyo, Japan, ²PRESTO-JST, Japan, ³NIMS, Japan

TuD4 MOSFET, HEMT & Nanowire FET

Room D (203) 16:30-18:30

Chair: J. A. del Alamo

TuD4-1 (Invited) 16:30 - 17:00

III-V MOS device technologies for advanced CMOS and tunneling FET

Shinichi Takagi^{1,2} and Mitsuru Takenaka^{1,2}

¹The University of Tokyo, Japan, ²JST-CREST, Japan

TuD4-2 17:00 - 17:15

Operation of 16-nm InGaAs channel multi-gate MOSFETs with regrown source/drain

Haruki Kinoshita, Nobukazu Kise, Atsushi Yukimachi, Toru Kanazawa, and Yasuyuki Miyamoto

Tokyo Institute of Technology, Japan

TuD4-3 17:15 - 17:30

In_{0.7}Ga_{0.3}As quantum-well MOSFETs with record g_m and effective mobility.

Seung-Woo Son, Jin Su Kim, Jung Ho Park, Ji Min Baek, Do-Kywn Kim, Jung-Hee Lee, and Dae-Hyun Kim

School of Electronics Engineering, Kyungpook National University, Republic of Korea

TuD4-4 17:30 - 17:45

Ultra-thin Body InAs-MOSFETs with elevated Source/Drain contacts

Mohamed Ridaoui,^{1,2} Matej Pastorek,¹ Alain Bruno Fadjie-Djomkam,¹ Nicolas Wichmann,¹ Abdelatif Jaouad,² Hassan Maher,² and Sylvain Bollaert¹

¹IEMN, CNRS UMR 8520, Université de Lille 1, France, ²LN2-CNRS UMI-3463, 3IT, Canada

TuD4-5 17:45 - 18:00

Gate delay analysis in two-step recess gate InGaAs-HEMTs with slant field plates

Tomotaka Hosotani, Taiichi Otsuji, and Tetsuya Suemitsu

RIEC, Tohoku University, Japan

TuD4-6 (Invited) 18:00 - 18:30

InAs/InP Core-shell Nanowire Transistors with Outstanding Device Performance

Satoshi Sasaki

NTT Basic Research Laboratories, Japan

June 29th (Wednesday)

WeB1 GaN: Electrical/ Optical Characterization Room B (201) 8:30-10:30

Chair: T.Kachi and S.Chichibu

WeB1-1 (Invited) 8:30 - 9:00

Characterization of n-type and p-type GaN layers grown on free-standing GaN substrates

Jun Suda and Masahiro Horita

Kyoto University, Japan

WeB1-2 9:00 - 9:15

A First-Principles Study of Carbon-Related Complexes and Energy Levels in GaN Using Heyd-Scuseria-Ernzerhof Hybrid Functionals

Masahiko Matsubara and Enrico Bellotti

Department of Electrical and Computer Engineering, Boston University, United States of America

WeB1-3 9:15 - 9:30

MOVPE Growth of N-polar GaN/Al_xGa_{1-x}N/GaN Heterostructure on Small Off-cut Substrate for Flat Interface

Kiattiwut Prasertsuk,^{1,3} Shinji Tanaka,¹ Tomoyuki Tanikawa,¹ Kanako Shojiki,¹ Takeshi Kimura,¹ Akinori Miura,¹ Ryohei Nonoda,¹ Fuyumi Hemmi,² Shigeyuki Kuboya,¹ Ryuji Katayama,¹ Tetsuya Suemitsu,² and Takashi Matsuoka¹

¹Institute for Materials Research, Tohoku University, Japan, ²Research Institute of Electrical Communication, Tohoku University, Japan, ³Thai Microelectronics Center, National Electronics and Computer Technology Center, Thailand

WeB1-4 9:30 - 9:45

Eu concentration dependence of Eu doped GaN nanocolumns grown by RF-plasma-assisted molecular beam epitaxy

Tomohiko Imanishi,¹ Hiroto Sekiguchi,¹ Satoshi Nishikawa,¹ Kohei Ozaki,¹ Keisuke Yamane,¹ Hiroshi Okada,² Katsumi Kishino,³ and Akihiro Wakahara¹

¹Department of Electrical and Electronic Information Engineering, Toyohashi University of Technology, Japan, ²Electronics-inspired Interdisciplinary Research Institute, Toyohashi University of Technology, Japan, ³Department of Engineering and Applied Science, Sophia University, Japan

WeB1-5 9:45 - 10:00

Introducing of Biexciton Processes into Exciton Dynamics Simulation for GaN Based on Collisional Phononic and Radiative Model

Kentaro Nomachi, Tomohiro Iwahori, Kensuke Oki, Bei Ma, Ken Morita, and Yoshihiro Ishitani

Chiba University, Japan

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| WeC1 | Extended Wavelength Photonic Devices | Room C (202) | 8:30-10:30 |
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Chair: H.Hirayama

WeC1-1 (Invited) **Cancelled 8:30 - 9:00**
Monolithic integration of a widely-tunable mid-infrared source based on DFB QCL array and echelle grating.

Grégory Maisons,¹ Clément Gilles,¹ Luis Orbe,² Guillermo Carpintero,² Johan Abautret,¹ and Mathieu Carras¹

¹*mirSense, France,* ²*Universidad Carlos III de Madrid, Spain*

WeC1-2 9:00 - 9:15
A novel patch-array antenna single-mode low electrical dissipation continuous wave Terahertz Quantum Cascade Laser

Lorenzo Bosco,¹ Christopher Benjamin Paul Bonzon,¹ Keita Otani,¹ Matthias Justen,² Mattias Beck,¹ and Jerome Faist¹

¹*Institute of Quantum Electronics, ETH Zürich, Switzerland,* ²*Institute of Physics, University of Cologne, Germany*

WeC1-3 9:15 - 9:30
Analysis of dual-section DFB-QCLs for spectroscopic applications

Martin Josef Suess,¹ Johanna Maria Wolf,¹ Pierre Jouy,¹ Christopher Bonzon,¹ Mattias Beck,¹ Morten Hundt,² Bela Tuzson,² Lukas Emmenegger,² and Jerome Faist¹

¹*Institute for Quantum Electronics, ETH Zürich, , Switzerland,* ²*Laboratory for Air Pollution and Environmental Technology, EMPA Duebendorf, Switzerland*

WeC1-4 9:30 - 9:45
ITO/nano-Ag Plasmonic Window Applied for Efficiency Improvement of Near-Ultraviolet Light Emitting Diodes

Ching-Ho Tien,¹ Chia-Hao Zhang,¹ Shih-Hao Chung,¹ Sin-Liang Ou,² Ray-Hua Horng,³ and Dong-Sing Wu^{1,2}

¹*Department of Materials Science & Engineering, National Chung Hsing University, Taiwan,* ²*Department of Materials Science & Engineering, Da-yeh University, Taiwan,* ³*Department of Electronics Engineering, National Chiao Tung University, Taiwan*

WeC1-5 9:45 - 10:00
A Novel Directional Light-Emitting Diode Based on Evanescent Wave Coupling

Xuelun Wang, Guodong Hao, and Naoya Toda

Electronics and Photonics Research Institute, AIST, Japan

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| WeD1 | Ultrahigh-frequency Devices | Room D (203) | 8:30-10:30 |
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Chair: T.Suemitsu

WeD1-1 (Invited) 8:30 - 9:00
InP/GaInAsSb DHBT Evolution in the THz Era

Colombo R. Bolognesi, Ralf Fluckiger, Maria Alexandrova, Rickard Löfvblom, and Olivier Ostinelli

Millimeter-wave Electronics Group, ETH-Zürich, Switzerland

WeD1-2 9:00 - 9:15
A High Efficiency RTD-based Sub-THz Differential Oscillator Pair for a Spatial Power Combining Array

Maengkyu Kim and Kyoungsoon Yang

Korea Advanced Institute of Science and Technology, Republic of Korea

WeD1-3 9:15 - 9:30
Improvement in Noise Characteristics of GaAsSb-based Backward Diodes by Using a Modified Junction Structure

Tsuyoshi Takahashi,^{1,2} Masaru Sato,^{1,2} Shoichi Shiba,^{1,2} Yasuhiro Nakasha,^{1,2} Naoki Hara,^{1,2} Taisuke Iwai,¹ Naoya Okamoto,¹ and Keiji Watanabe¹

¹Fujitsu Laboratories Ltd., Japan, ²Fujitsu Limited, Japan

WeD1-4 9:30 - 9:45
Frequency Increase in Resonant-Tunneling-Diode Terahertz Oscillator by Reduction in Conduction Loss with Thick Antenna Electrode

Takeru Maekawa, Hidetoshi Kanaya, Safumi Suzuki, and Masahiro Asada

Tokyo Institute of Technology, Japan

WeD1-5 9:45 - 10:00
InSb-based HEMT with Over 300 GHz- f_T using Evaporated SiO_x Film

Kyousuke Isono,¹ Daisuke Tsuji,¹ Tatsuya Taketsuru,¹ Sachie Fujikawa,¹ Issei Watanabe,² Yoshimi Yamashita,² Akira Endoh,² Shinsuke Hara,² Akifumi Kasamatsu,² and Hiroki I. Fujishiro¹

¹Tokyo University of Science, Japan, ²National Institute of Information and Communications Technology, Japan

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| <i>Coffee Break</i> | 10:00 - 10:30 |
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| WeB2 GaN: Electron Devices | Room B (201) 10:30-12:00 |
| <i>Chair: N.Nakata and J.Suda</i> | |

WeB2-1 (Invited) 10:30 - 11:00
Performance Enhancement and Characterization Techniques for GaN Power Devices

Shu Yang,^{1,2} Shenghou Liu,¹ Cheng Liu,¹ Mengyuan Hua,¹ Giorgia Longobardi,² Florin Udrea,² and Kevin J. Chen¹

¹The Hong Kong University of Science and Technology, Hong Kong, ²University of Cambridge, United Kingdom

WeB2-2 11:00 - 11:15
Controllability improvement of Al₂O₃-gate structure for GaN transistors

Kenya Nishiguchi, Joji Ohira, Syota Kaneki, Syota Toiya, and Tamotsu Hashizume

RCIQE, Hokkaido Univ, Japan

WeB2-3 11:15 - 11:30
High Pressures Water Vapor Annealing for Atomic-Layer-Deposited Al₂O₃ on GaN
 Koji Yoshitugu, Masahiro Horita, Mustunori Uenuma, Yasuaki Ishikawa, and Yukiharu Uraoka
Nara Institute of Science and Technology, Japan

WeB2-4 11:30 - 11:45
The effect of neutral beam etching on device isolation in AlGaIn/GaN HEMTs
 Fuyumi Hemmi,¹ Cedric Thomas,² Yi-Chun Lai,³ Akio Higo,³ Alex Guo,⁴ Shireen Warnock,⁴ Jesús. A. del Alamo,⁴ Seiji Samukawa,^{2,3} Taiichi Otsuji,¹ and Tetsuya Suemitsu¹
¹Research Institute of Electrical Communication, Tohoku University, Japan, ²Institute of Fluid Science, Tohoku University, Japan, ³Advanced Institute of Materials Research, Tohoku University, Japan, ⁴Microsystems Technology Laboratories, Massachusetts Institute of Technology, United States of America

WeB2-5 11:45 - 12:00
AlGaIn/GaN High Electron Mobility Transistors on Si with Sputtered TiN Gate
 Yang Li,¹ Geok Ing Ng,^{1,2} Subramaniam Arulkumaran,² Chandra Mohan Manoj Kumar,² Kian Siong Ang,² and Zhi Hong Liu³
¹School of Electrical and Electronic Engineering, Nanyang Technological University, Singapore, ²Tamasek Laboratories, Nanyang Technological University, Singapore, ³Singapore-MIT Alliance of Research and Technology, Singapore

WeC2 Novel Materials

Room C (202) 10:30-12:00

Chair: K.Ishibashi

WeC2-1 (Invited) 10:30 - 11:00
Topological Spintronics
 Nitin Samarth
Dept. of Physics, The Pennsylvania State University, United States of America

WeC2-2 11:00 - 11:15
Robust Manipulation of Magnetism in Dilute Magnetic Semiconductor (Ga,Mn)As by Organic Molecules
 Xiaolei Wang,¹ Hailong Wang,¹ Dong Pan,¹ Timothy Keiper,² Lixia Li,¹ Xuezhe Yu,¹ Jun Lu,¹ Eric Lochner,² Stephan von Molnar,² Peng Xiong,² and Jianhua Zhao¹
¹State Key Laboratory of Superlattices and Microstructures, Institute of Semiconductors, Chinese Academy of Sciences, China, ²Department of Physics, Florida State University, United States of America

WeC2-3 11:15 - 11:30
High-temperature ferromagnetism in heavily Fe-doped ferromagnetic semiconductor (Ga,Fe)Sb
 Nguyen Thanh Tu,¹ Pham Nam Hai,^{1,2} Le Duc Anh,¹ and Masaaki Tanaka¹
¹Department of Electrical Engineering & Information Systems, The University of Tokyo, Japan, ²Department of Physical Electronics, Tokyo Institute of Technology, Japan

WeC2-4 11:30 - 11:45
Bandgap Engineering for Normally-off GaAsSb/InGaAs Hetero-junction Tunneling Field-Effect Transistors with High On-state Current

Jhieh-Cheng Wu,¹ Cheng-Yu Chen,¹ and Jen-Inn Chyi^{1,2}

¹Department of Electrical Engineering, National Central University, Zhongli, Taiwan, ²Research Center for Applied Sciences, Academia Sinica, Taipei, Taiwan

WeC2-5 11:45 - 12:00
Frequency Division Multiplexed Logic Circuits in a GaAs/AlGaAs-Based Phonon Waveguide

Daiki Hatanaka, Tom Darras, Imran Mahboob, Koji Onomitsu, and Hiroshi Yamaguchi

NTT Basic Research Laboratories, Japan

WeD2 Growth techniques

Room D (203) 10:30-12:00

Chair: T.Suemasu

WeD2-1 (Invited) 10:30 - 11:00
In Situ X-Ray Measurement of Changes in Buried Structure during Crystal Growth

Masamitsu Takahashi

National Institutes for Quantum and Radiological Science and Technology, Japan

WeD2-2 11:00 - 11:15
GaAs first-spacer-layer thickness dependence of polarized photoluminescence properties of closely-stacked InAs/GaAs quantum dots with long-wavelength emission

Yusuke Tajiri, Toshiyuki Kaizu, and Takashi Kita

Department of Electrical and Electronic Engineering, Graduate School of Engineering, Kobe University, Japan

WeD2-3 11:15 - 11:30
Structural and Optical Properties of High Bi Content GaSbBi Films Grown by Molecular Beam Epitaxy

Li Yue,¹ Yanchao Zhang,¹ Fan Zhang,¹ Lijuan Wang,¹ Yunshen Zhuzhong,¹ Juanjuan Liu,¹ and Shumin Wang²

¹State Key Laboratory of Functional Materials for Informatics, Shanghai Institute of Microsystem and Information Technology, CAS, China, ²Department of Microtechnology and Nanoscience, Chalmers University of Technology, Sweden

WeD2-4 11:30 - 11:45
Enhanced Thermoelectric Properties of ZLAST by Combinatorial Sputtering Approach

Shih Chun Tseng, Wen Hsuan Chao, Ping Hsing Yang, and Hsu Shen Chu

Material and Chemical Research Laboratories, Industrial Technology Research Institute, Taiwan

WeD2-5 11:45 - 12:00
Observation of pn-junction depth in Mg₂Si photodiode fabricated by thermal diffusion of Ag acceptor

Haruhiko Udono,¹ Nobuhiko Hori,¹ Tomohiro Akiyama,¹ Yuuma Onizawa,¹ Tsubasa Ootsubo,¹ and Fumitaka Esaka²

¹Ibaraki University, Japan, ²Japan Atomic Energy Agency, Japan

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| Excursion | 12:30 - 18:45 |
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| Banquet | ANA Crown Plaza Banquet Room "OHTORI" 19:00 - 21:00 |
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June 30th (Thursday)

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| ThB1 | GaN: Optical Devices | Room B (201) | 8:30-10:00 |
| Chair: Y.Ishitani and K.M.Lau | | | |

ThB1-1 8:30 - 8:45

Measurement of Internal Loss, Injection Efficiency, and Gain for Continuous-wave Semipolar ($2\bar{0}\bar{2}\bar{1}$) III-nitride Laser Diodes

Daniel Becerra,¹ Leah Kuritzky,¹ Joseph Nedy,² Arwa Abbas,¹ Arash Pourhashemi,¹ Robert Farrell,¹ Daniel Cohen,¹ Steven DenBaars,^{1,2} James Speck,¹ and Shuji Nakamura^{1,2}

¹Materials Department, University of California Santa Barbara, United States of America, ²Department of Electrical and Computer Engineering, University of California Santa Barbara, United States of America

ThB1-2 8:45 - 9:00

Efficient Use of Uniform GaN HVLEDs for Small-Flicker General Illumination Applications with Converter-free LED Drivers

Yuefei Cai,¹ Xinbo Zou,^{1,2} Yuan Gao,¹ Lisong Li,¹ Philip K.T. Mok,¹ and Kei May Lau^{1,2}

¹Department of Electronic and Computer Engineering, Hong Kong University Science and Technology, Hong Kong, ²Jockey Club Institute for Advanced Study, Hong Kong University Science and Technology, Hong Kong

ThB1-3 9:00 - 9:15

Fabrication of InGaN/GaN multi quantum well based nano-LEDs by hydrogen environment anisotropic thermal etching (HEATE) technique

Kohei Ogawa,¹ Ryo Hachiya,¹ Tomoya Mizutani,¹ Shun Ishijima,¹ and Akihiko Kikuchi^{1,2}

¹Sophia University, Japan, ²Sophia Nanotechnology Research Center, Japan

ThB1-4 9:15 - 9:30

High-speed Performance of III-nitride 410 nm Ridge Laser Diode on ($2\bar{0}\bar{2}\bar{1}$) plane for Visible Light Communication

Changmin Lee,¹ Chong Zhang,² Daniel L Becerra,¹ Seungguen Lee,² Robert M Farrell,^{1,2} James S Speck,¹ Shuji Nakamura,^{1,2} John E Bowers,^{1,2} and Steven P DenBaars^{1,2}

¹Materials Department, University of California, Santa Barbara, United States of America, ²Department of Electrical & Computer Engineering, University of California, Santa Barbara, United States of America

ThB1-5 9:30 - 9:45

Improved conversion efficiency of InN/p-GaN heterojunction solar cells with the InON quantum dots interlayer

Zhong-Yi Liang,¹ Cheng-Yi Yang,¹ Yu-Teng Chan,² Chi-Yung Jiang,² and Wen-Cheng Ke¹

¹Department of Materials Science and Engineering, National Taiwan University of Science and Technology, Taiwan,

²Department of Mechanical Engineering, Yuan Ze University, Taiwan

ThB1-6 9:45 - 10:00

Breakdown of the Green Gap in (0001) InGaN LEDs

Markus Pristovsek,¹ Rachel A. Oliver,¹ Tom Badcock,² Muhammad Ali,² and Andrew Shields²

¹Department of Materials Science and Metallurgy, University of Cambridge, United Kingdom, ²Toshiba Research Europe Ltd., United Kingdom

ThLN Late News

Room B (201) 10:00-10:30

Chair: Y.Ishitani and K.M.Lau

ThLN1 10:00 - 10:15

Hybrid MOCVD/MBE GaN Tunnel Junction LEDs with Greater than 70% Wall Plug Efficiency

Benjamin P. Yonkee,¹ Erin C. Young,¹ John T. Leonard,¹ Changmin Lee,² Sang Ho Oh,² Steven P. DenBaars,^{1,2} James S. Speck,¹ and Shuji Nakamura^{1,2}

¹Materials Department, University of California, Santa Barbara, United States of America, ²Department of Electrical And Computer Engineering, University of California, Santa Barbara, United States of America

ThLN2 10:15 - 10:30

GaSb lasers grown on Silicon substrate emitting in the telecom wavelength range

Andrea Castellano,^{1,2,3} Laurent Cerutti,^{1,2} Grégoire Narcy,^{1,2} Jean-Baptiste Rodriguez,^{1,2} Alexandre Garreau,³ François Lelarge,³ and Eric Tournié^{1,2}

¹University of Montpellier, France, ²CNRS, France, ³III-V Lab, France

ThC1 Oxide Materials & Properties

Room C (202) 8:30-10:30

Chair: M. Nakano and G.Jessen

ThC1-1 (Invited) 8:30 - 9:00

Ternary and quaternary wurtzite-type oxide semiconductors: β -CuGaO₂ and its related materials

Takahisa Omata,^{1,2} Yuki Mizuno,² Issei Suzuki,² Hiraku Nagatani,² and Masao Kita³

¹IMRAM, Tohoku University, Japan, ²Graduate School of Engineering, Osaka University, Japan, ³Department of Mechanical Engineering, National Institute of Technology, Toyama College, Japan

ThC1-2 9:00 - 9:15

Transparent Conducting Amorphous CdO-Ga₂O₃ Films Synthesized by Room Temperature Sputtering

Kin Man Yu,¹ Chaoping Liu,¹ Chun Yuen Ho,¹ Yishu Foo,¹ M Kamruzzaman,¹ Juan Antonio Zapien,¹ Weiwei Gao,² and Wladek Walukiewicz²

¹Department of Physics and Materials Science, City Univerisity of Hong Kong, Hong Kong, ²Materials Sciences Division, Lawrence Berkeley National Laboratory, Berkeley, United States of America

ThC1-3 9:15 - 9:30
Formation of Nanoscale Composites of Compound Semiconductors Driven by Charge Transfer

Weiwei Gao,¹ Roberto Reis,^{1,2} Laura Schelhas,³ Vanessa Vanessa L. Pool,³ Michael Toney,³ Kin Man Yu,^{1,4} and Wladek Walukiewicz¹

¹Materials Sciences Division, Lawrence Berkeley National Laboratory, United States of America, ²National Center for Electron Microscopy/molecular Foundry, Lawrence Berkeley National Laboratory, United States of America, ³Stanford Synchrotron Radiation Lightsource, SLAC National Accelerator Laboratory, United States of America, ⁴Department of Physics and Materials Science, City University of Hong Kong, Hong Kong

ThC1-4 (Invited) 9:30 - 10:00
Band Offsets of Oxide, 3D and 2D Semiconductors and their Implications

John Robertson

Cambridge University, Cambridge, United Kingdom

ThC1-5 10:00 - 10:15
Characterization of band offset in α -(Al_xGa_{1-x})₂O₃/ α -Ga₂O₃ heterostructures

Takayuki Uchida, Riena Jinno, Shu Takemoto, Kentaro Kaneko, and Shizuo Fujita

Graduate School of Engineering, Kyoto University, Japan

ThC1-6 10:15 - 10:30
First principles study of the diffusion of oxygen vacancies in Ga₂O₃

Alexandros Kyrtos, Masahiko Matsubara, and Enrico Bellotti

Department of Electrical and Computer Engineering, Boston University, United States of America

ThD1 Heterogeneous Integration & High-speed Lasers Room D (203) 8:30-10:30

Chair: Y. Matsui

ThD1-1 (Invited) 8:30 - 9:00
Heterogeneous Integration of InP Devices on Silicon

Zhechao Wang,^{1,2} Marianna Pantouvaki,² Geert Morthier,¹ Clement Merckling,² Joris van Campenhout,² Dries van Thourhout,¹ and Gunther Roelkens¹

¹Ghent University, Belgium, ²IMEC, Belgium

ThD1-2 9:00 - 9:15
Continuous-wave Operation of Ultra-short Cavity Distributed Bragg Reflector Lasers on Si Substrates

Koji Takeda,^{1,2} Erina Kanno,¹ Takuro Fujii,^{1,2} Koichi Hasebe,^{1,2} Tsuyoshi Yamamoto,¹ Takaaki Kakitsuka,^{1,2} and Shinji Matsuo^{1,2}

¹NTT Device Technology Labs., Japan, ²Nanophotonics Center, Japan

ThD1-3 9:15 - 9:30
10 Gbps Operation of Membrane DFB Laser on Silicon with Record High Modulation Efficiency

Daisuke Inoue,¹ Takuo Hiratani,¹ Kai Fukuda,¹ Takahiro Tomiyasu,¹ Tomohiro Amemiya,² Nobuhiko Nishiyama,¹ and Shigehisa Arai^{1,2}

¹Department of Electrical and Electronic Engineering, Tokyo Institute of Technology, Japan, ²Quantum Nanoelectronics Research Center, Tokyo Institute of Technology, Japan

ThD1-4 9:30 - 9:45
GaInAsP/SOI Hybrid Laser with AlInAs-oxide Confinement Structure Fabricated by Plasma Activated Bonding

Junichi Suzuki,¹ Satoshi Inoue,¹ Shovon MD Tanvir Hasan,¹ Yusuke Hayashi,¹ Tomohiro Amemiya,² Nobuhiko Nishiyama,¹ and Shigehisa Arai^{1,2}

¹Department of Electrical and Electronic Engineering, Tokyo Institute of Technology, Japan, ²Quantum Nanoelectronics Research Center, Japan

ThD1-5 9:45 - 10:00
Design and Fabrication of Directly-Modulated 1.3- μ m Lateral-current-injection Lasers

Koichi Hasebe, Junichi Nishinaka, Takuro Fujii, Koji Takeda, Tsuyoshi Yamamoto, Takaaki Kakitsuka, and Shinji Matsuo

NTT Device Technology Labs, NTT Corporation, Japan

ThD1-6 10:00 - 10:15
Analysis of Voltage Dependence on Lasing Characteristics of 1.3- μ m npn-AlGaInAs/InP Transistor Lasers

Shotaro Tadano,¹ Takaaki Kaneko,¹ Kentaro Yamanaka,¹ Nobuhiko Nishiyama,¹ and Shigehisa Arai^{1,2}

¹Department of Electrical and Electronic Engineering, Tokyo Institute of Technology, Japan, ²Quantum Nanoelectronics Research Center, Japan

ThD1-7 10:15 - 10:30
Transmission Performance Improvement of Semiconductor Lasers by Hybrid Modulation Scheme

Shigeru Mieda,¹ Nobuhide Yokota,¹ Wataru Kobayashi,² and Hiroshi Yasaka¹

¹Tohoku University, Japan, ²NTT Corporation, Japan

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| <i>Coffee Break</i> | 10:30 - 11:00 |
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ThB2 High-frequency & high-power Devices

Room B (201) 11:00-12:30

Chair: M. Kuzuhara and S.Arulkumaran

ThB2-1 (Invited) 11:00 - 11:30
Vertical GaN Bipolar Devices: Gaining Competitive Advantage from Photon Recycling

Kazuhiro Mochizuki

¹National Institute of Advanced Industrial Science and Technology, Japan, ²Hitachi, Ltd., Japan

ThB2-2 11:30 - 11:45
Impact of AlGa_N Barrier Recess on the DC and Dynamic Characteristics of AlGa_N/Ga_N Schottky Barrier Diodes with Gated Edge Termination

Jie Hu,^{1,2} Steve Stoffels,² Silvia Lenci,² Nicolò Ronchi,² Brice De Jaeger,² Shuzhen You,² Benoit Bakeroot,^{2,3} Guido Groeseneken,^{1,2} and Stefaan Decoutere²

¹ESAT-MICAS, KU Leuven, Leuven 3001, Belgium, ²IMEC, Kapeldreef 75, Leuven 3001, Belgium, ³Ghent University, Ghent 9052, Belgium

ThB2-3 11:45 - 12:00
G-Band MMIC Resonant Tunneling Diode Oscillators

Jue Wang, Abdullah Khalidi, Khalid Alharbi, Afesomah Ofiare, Haiping Zhou, and Edward Wasige

University of Glasgow, United Kingdom

ThB2-4 12:00 - 12:15
Experimental Demonstration of Strain Detection Using Resonant Tunneling Delta-Sigma Modulation Sensors

Takumi Tajika, Yuichiro Kakutani, Masayuki Mori, and Koichi Maezawa

Graduate School of Science and Engineering, University of Toyama, Japan

ThB2-5 12:15 - 12:30
Lamb Wave Dispersion in Gallium Nitride Micromechanical Resonators

Haoshen Zhu, Azadeh Ansari, and Mina Rais-Zadeh

Department of Electrical Engineering and Computer Science, University of Michigan, United States of America

ThC2 Nanocarbon Applications

Room C (202) 11:00-12:30

Chair: A. Kanda

ThC2-1 (Invited) 11:00 - 11:30
Graphene for Digital Logic Applications

Hyeonjun Hwang, Jinho Yang, Yunji Kim, Sangkyung Lee, and Byoung Hun Lee

Gwangju Institute of Science and Technology, Republic of Korea

ThC2-2 11:30 - 11:45
Observation of Spontaneous Terahertz Emission from Optically Pumped Monolayer Intrinsic Graphene

Takayuki Watanabe,¹ Hiroyuki Wako,¹ Akira Satou,¹ Alexander A. Dubinov,² Kenji Kawahara,³ Hiroki Ago,³ Victor Ryzhii,¹ and Taiichi Otsuji¹

¹Research Institute of Electrical Communication, Tohoku University, Japan, ²Institute for Physics of Microstructures, RAS, Lobachevsky State University, Russia, ³Institute for Materials Chemistry and Engineering, Kyushu University, Japan

ThC2-3 11:45 - 12:00
An Application of Graphene Field Effect Transistor to Enzymatic Assay

Takao Ono,¹ Yasushi Kanai,¹ Yasuhide Ohno,^{1,2} Kenzo Maehashi,^{1,3} Koichi Inoue,¹ and Kazuhiko Matsumoto¹

¹The Institute of Scientific and Industrial Research, Osaka University, Japan, ²Graduate School of Science and Technology, Tokushima University, Japan, ³Institute of Engineering, Tokyo University of Agriculture and Technology, Japan

ThC2-4 12:00 - 12:15

Large Scale Fabrication of Suspended Graphene Nanoribbon Arrays

Hiroo Suzuki, Toshiaki Kato, and Toshiro Kaneko

Department of Electronic Engineering, Tohoku University, Japan

ThC2-5 12:15 - 12:30

Electrostatic actuation of electrically floating carbon nanotube cantilever

Kenshi Inotani, Kuniharu Takei, Takayuki Arie, and Seiji Akita

Department of Physics and Electronics, Osaka Prefecture University, Japan

ThD2 Group-III Nitrides Growth

Room D (203) 11:00-12:30

Chair: T.Suemasu and M. Takahashi

ThD2-1 (Invited) 11:00 - 11:30

Large Area Flexible Devices Based on Group-III Nitrides

Hiroshi Fujioka,^{1,2} Kohei Ueno,¹ Atsushi Kobayashi,¹ and Jitsuo Ohta¹

¹Institute of Industrial Science, The University of Tokyo, Japan, ²JST-ACCEL, Japan

ThD2-2 11:30 - 11:45

Influences of Mask Materials in Selective-Area RF-MBE Growth for GaN Nanowires

Naoto Tamaki, Akihito Sonoda, Aya Onodera, and Junichi Motohisa

Graduate School of Information Science and Technology, Hokkaido University, Japan

ThD2-3 11:45 - 12:00

High Quality Bulk GaN Crystal Grown by Acidic Ammonothermal Method

Quanxi Bao,^{1,3} Makoto Saito,^{1,2} Kouhei Kurimoto,³ Daisuke Tomida,¹ Kazunobu Kojima,¹ Yuji Kagamitani,² Rinzo Kayano,³ Tohru Ishiguro,¹ and Shigefusa F. Chichibu¹

¹Institute of Multidisciplinary Research for Advanced Materials, Tohoku University, Japan, ²Mitsubishi Chemical Corp., Japan, ³The Japan Steel Works, Japan

ThD2-4 12:00 - 12:15

Realization of Conductive AlN Epitaxial Layer on Si Substrate using Spontaneously Formed Nano-Size Via-Holes for Vertical AlGaIn High Power FET

Noriko Kurose,¹ Kota Ozeki,² Tsutomu Araki,² Naotaka Iwata,³ Itaru Kamiya,³ and Yoshinobu Aoyagi¹

¹Research Organization of Science and Technology, Ritsumeikan University, Japan, ²Faculty of Science and Technology, Ritsumeikan University, Japan, ³Faculty of Engineering, Toyota Technological Institute, Japan

ThD2-5 12:15 - 12:30

Improvement of 1.0 eV GaInNAsSb solar cell performance upon annealing

Naoya Miyashita,^{1,2} Nazmul Ahsan,^{1,2} and Yoshitaka Okada^{1,2}

¹RCAST, The University of Tokyo, Japan, ²NextPV, RCAST and CNRS, The University of Tokyo, Japan

Closing and Student Award Ceremony

Room A (Main Hall) 12:30-13:00